



# 4GB LPDDR4X SDRAM Datasheet

**CXDB5CBAM-MA-B**

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ChangXin Memory Technologies, Inc.

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Revision History

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# 1. Core Specifications

Through this section you will read contents as below:

Ordering Options [on Page 8](#)

Part Number Decoding [on Page 8](#)

Address Table [on Page 8](#)

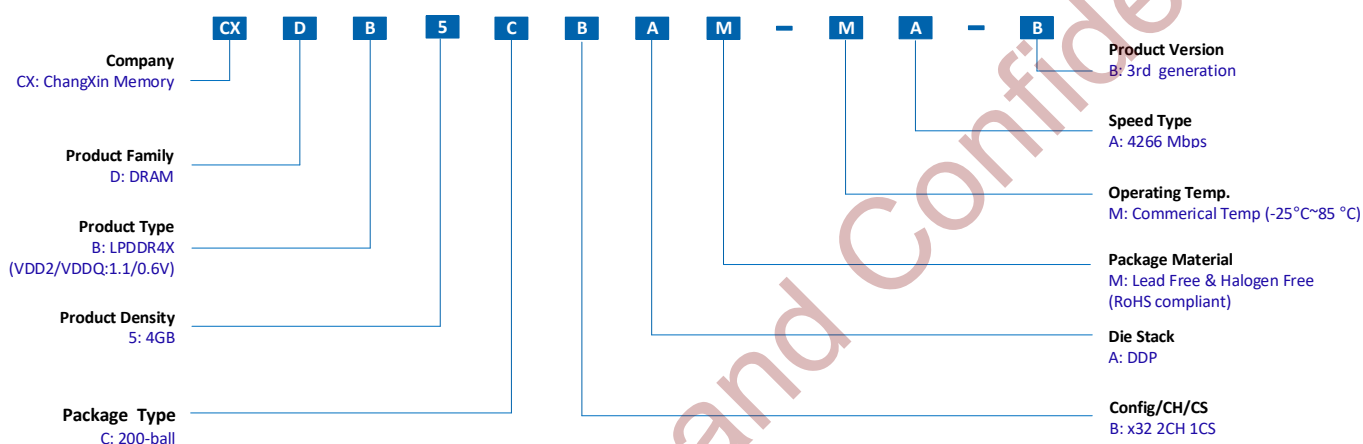
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## 1.1 Ordering Options

Table 1-1 LPDDR4X Device Ordering Information

| Part Number    | Density | Organization | Data Rate | Package           |
|----------------|---------|--------------|-----------|-------------------|
| CXDB5CBAM-MA-B | 4GB     | 2CH x32      | 4266 Mbps | 200 Ball Discrete |

## 1.2 Part Number Decoding



## 1.3 Address Table

Table 1-2 Die Addressing Table

| Die Configuration | 128Mb x16DQ x8Banks x1CH |
|-------------------|--------------------------|
| Bank Address      | BA0~BA2                  |
| Row Address       | R0~R16                   |
| Column Address    | C0~C9                    |

## 2. Physical Specifications

This chapter will introduce the 200-ball discrete package dimension, ballout assignment and pad definition.

- 200-Ball x32 Discrete Package Dimension [on Page 10](#)
- x32 Discrete Package Ballout [on Page 11](#)
- Block Diagram [on Page 12](#)
- Pad Definition [on Page 13](#)

## 2.1 200-Ball x32 Discrete Package Dimension

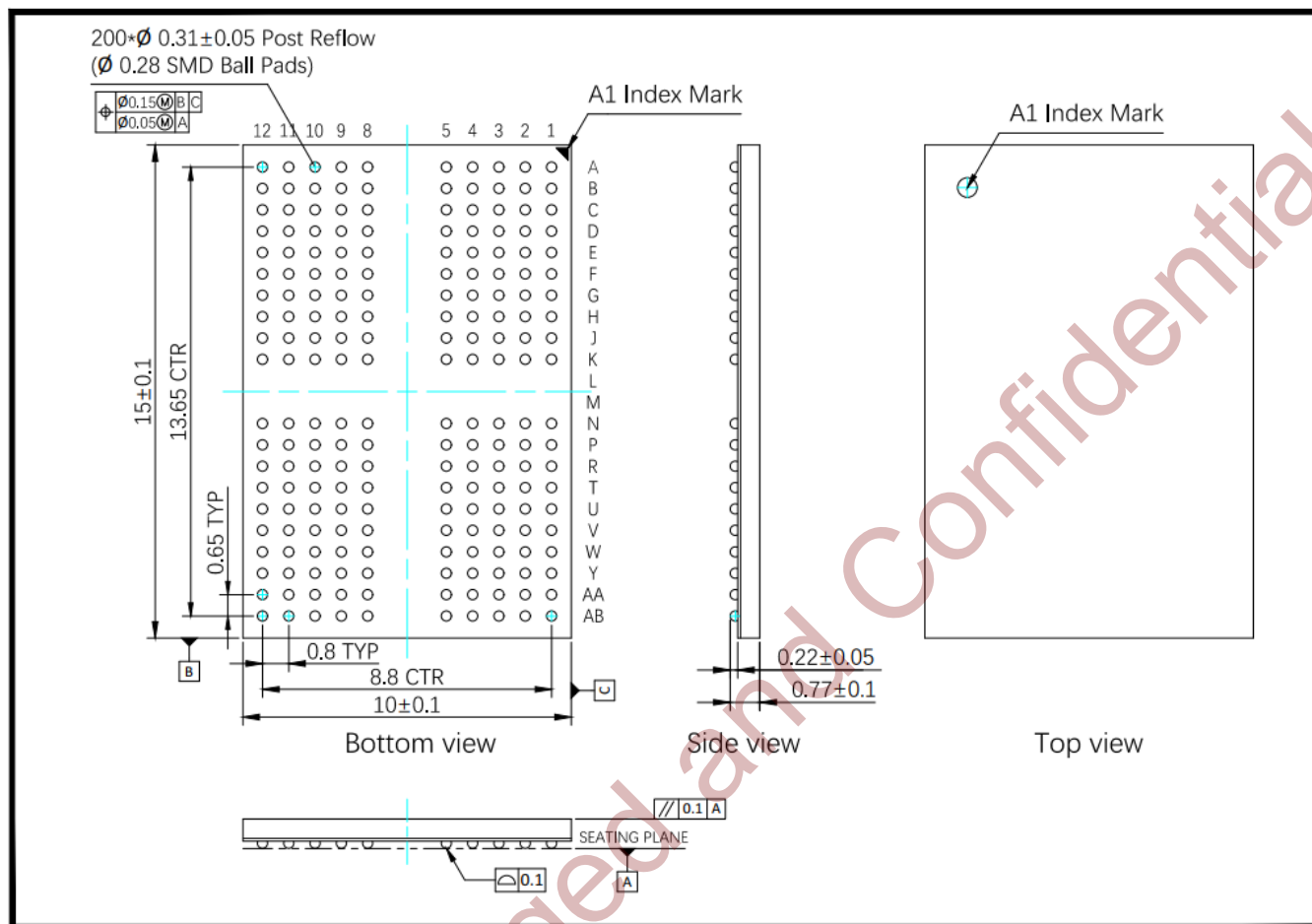


Figure 2-1 200-Ball x32 Discrete FBGA Package Dimension

## 2.2 x32 Discrete Package Ballout

|    | 1    | 2       | 3        | 4      | 5      | 6 | 7 | 8      | 9              | 10       | 11      | 12   |
|----|------|---------|----------|--------|--------|---|---|--------|----------------|----------|---------|------|
| A  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | DNU  | DNU     | VSS      | VDD2   | ZQ0    |   |   | ZQ1    | VDD2           | VSS      | DNU     | DNU  |
| B  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | DNU  | DQ0_A   | VDDQ     | DQ7_A  | VDDQ   |   |   | VDDQ   | DQ15_A         | VDDQ     | DQ8_A   | DNU  |
| C  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | DQ1_A   | DMIO_A   | DQ6_A  | VSS    |   |   | VSS    | DQ14_A         | DMIO_A   | DQ9_A   | VSS  |
| D  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDDQ | VSS     | DQS0_t_A | VSS    | VDDQ   |   |   | VDDQ   | VSS            | DQS1_t_A | VSS     | VDDQ |
| E  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | DQ2_A   | DQS0_c_A | DQ5_A  | VSS    |   |   | VSS    | DQ13_ADQS1_c   | ADQ10_A  | VSS     |      |
| F  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD1 | DQ3_A   | VDDQ     | DQ4_A  | VDD2   |   |   | VDD2   | DQ12_A         | VDDQ     | DQ11_A  | VDD1 |
| G  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | ODTCA_A | VSS      | VDD1   | VSS    |   |   | VSS    | VDD1           | VSS      | ZQ2     | VSS  |
| H  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD2 | CA0_A   | CS1_A    | CS0_A  | VDD2   |   |   | VDD2   | CA2_A          | CA3_A    | CA4_A   | VDD2 |
| J  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | CA1_A   | VSS      | CKE0_A | CKE1_A |   |   | CK_t_A | CK_c_A         | VSS      | CA5_A   | VSS  |
| K  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD2 | VSS     | VDD2     | VSS    | CS2_A  |   |   | CKE2_A | VSS            | VDD2     | VSS     | VDD2 |
| N  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD2 | VSS     | VDD2     | VSS    | CS2_B  |   |   | CKE2_B | VSS            | VDD2     | VSS     | VDD2 |
| P  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | CA1_B   | VSS      | CKE0_B | CKE1_B |   |   | CK_t_B | CK_c_B         | VSS      | CA5_B   | VSS  |
| R  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD2 | CA0_B   | CS1_B    | CS0_B  | VDD2   |   |   | VDD2   | CA2_B          | CA3_B    | CA4_B   | VDD2 |
| T  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | ODTCA_B | VSS      | VDD1   | VSS    |   |   | VSS    | VDD1           | VSS      | RESET_n | VSS  |
| U  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDD1 | DQ3_B   | VDDQ     | DQ4_B  | VDD2   |   |   | VDD2   | DQ12_B         | VDDQ     | DQ11_B  | VDD1 |
| V  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | DQ2_B   | DQS0_c_B | DQ5_B  | VSS    |   |   | VSS    | DQ13_BDQS1_c_B | DQ10_B   | VSS     |      |
| W  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VDDQ | VSS     | DQS0_t_B | VSS    | VDDQ   |   |   | VDDQ   | VSS            | DQS1_t_B | VSS     | VDDQ |
| Y  | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | VSS  | DQ1_B   | DMIO_B   | DQ6_B  | VSS    |   |   | VSS    | DQ14_B         | DMIO_B   | DQ9_B   | VSS  |
| AA | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | DNU  | DQ0_B   | VDDQ     | DQ7_B  | VDDQ   |   |   | VDDQ   | DQ15_B         | VDDQ     | DQ8_B   | DNU  |
| AB | ○    | ○       | ○        | ○      | ○      |   |   | ○      | ○              | ○        | ○       | ○    |
|    | DNU  | DNU     | VSS      | VDD2   | VSS    |   |   | VSS    | VDD2           | VSS      | DNU     | DNU  |

Figure 2-2 x32 Discrete Package Ballout

### Note:

- 0.8mm pitch (X-axis), 0.65mm pitch (Y-axis), 22 rows using MO-311 0.80mm Pitch
- Top View, A1 in top left corner. CS1\_A/B, CE1\_A/B, ZQ1 is floating for 2GB package.
- ODT(ca)\_[x] balls are wired to ODT(ca)\_[x] pads of Rank 0 DRAM die. ODT(ca)\_[x] pads for other ranks (if present) are disabled in the package.
- ZQ2, CKE2\_A, CKE2\_B, CS2\_A, and CS2\_B balls are reserved for 3-rank package. For 1-rank and 2-rank package those balls are NC.
- Die pad VSS and VSSQ signals are combined to VSS package balls.
- Package requires dual channel die or functional equivalent of single channel die-stack.

## 2.3 Block Diagram

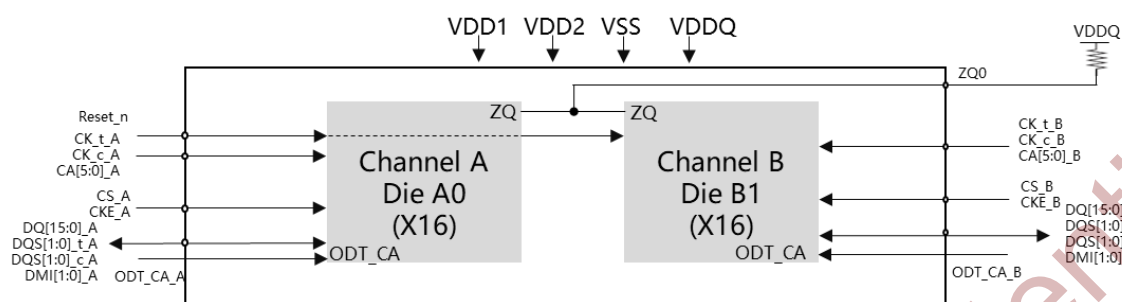


Figure 2-3 Double-Die, Dual-Channel, One-Rank Package Block Diagram (4GB x32 I/O)

## 2.4 Pad Definition

“\_A” and “\_B” indicate DRAM channels. “\_A” pads are present in all devices while “\_B” pads are present in dual channel SDRAM devices only.

Table 2-1 Pad Definition

| Symbol                                                    | Type  | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|-----------------------------------------------------------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| CK_t_A, CK_c_A,<br>CK_t_B, CK_c_B                         | Input | <b>Clock:</b> CK_t and CK_c are differential clock inputs. All address, command, and control input signals are sampled on the crossing of the positive edge of CK_t and the negative edge of CK_c. AC timings for CA parameters are referenced to CK. Each channel (A & B) has its own clock pair.                                                                                                                                                                                                                            |
| CKE_A, CKE_B                                              | Input | <b>Clock Enable:</b> CKE HIGH activates and CKE LOW deactivates the internal clock circuits, input buffers, and output drivers. Power-saving modes are entered and exited via CKE transitions. CKE is part of the command code. Each channel (A & B) has its own CKE signal.                                                                                                                                                                                                                                                  |
| CS_A, CS_B                                                | Input | <b>Chip Select:</b> CS is part of the command code. Each channel (A & B) has its own CS signal.                                                                                                                                                                                                                                                                                                                                                                                                                               |
| CA[5:0]_A, CA[5:0]_B                                      | Input | <b>Command/Address Inputs:</b> CA signals provide the Command and Address inputs according to the Command Truth Table. Each channel (A&B) has its own CA signals.                                                                                                                                                                                                                                                                                                                                                             |
| DQ[15:0]_A, DQ[15:0]_B                                    | I/O   | <b>Data Input/Output:</b> Bi-direction data bus.                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| DQS[1:0]_t_A, DQS[1:0]_c_A,<br>DQS[1:0]_t_B, DQS[1:0]_c_B | I/O   | <b>Data Strobe:</b> DQS_t and DQS_c are bi-directional differential output clock signals used to strobe data during a READ or WRITE. The Data Strobe is generated by the DRAM for a READ and is edge-aligned with Data. The Data Strobe is generated by the Memory Controller for a WRITE and must arrive prior to Data. Each byte of data has a Data Strobe signal pair. Each channel (A & B) has its own DQS strobes.                                                                                                       |
| DMI[1:0]_A, DMI[1:0]_B                                    | I/O   | <b>Data Mask Inversion:</b> DMI is a bi-directional signal which is driven HIGH when the data on the data bus is inverted, or driven LOW when the data is in its normal state. Data Inversion can be disabled via a mode register setting. Each byte of data has a DMI signal. Each channel (A & B) has its own DMI signals. This signal is also used along with the DQ signals to provide write data masking information to the DRAM. The DMI pin function - Data Inversion or Data mask - depends on Mode Register setting. |

| Symbol            | Type      | Description                                                                                                                                                                                                          |
|-------------------|-----------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| ZQ                | Reference | <b>Calibration Reference:</b> Used to calibrate the output drive strength and the termination resistance. There is one ZQ pin per die. The ZQ pin shall be connected to VDDQ through a $240\Omega \pm 1\%$ resistor. |
| VDDQ,VDD1,VDD2    | Supply    | <b>Power Supplies:</b> Isolated on the die for improved noise immunity.                                                                                                                                              |
| VSS, VSSQ         | GND       | <b>Ground Reference:</b> Power supply ground reference                                                                                                                                                               |
| RESET_n           | Input     | <b>RESET:</b> When asserted LOW, the RESET_n signal resets all channels of the die. There is one RESET_n pad per die.                                                                                                |
| ODT_CA_A,ODT_CA_B | Input     | <b>CA ODT Control:</b><br><b>LPDDR4X:</b> The ODT_CA pin is ignored by LPDDR4X devices. ODT_CS/CA/CK Function is fully controlled through MR11 and MR22. TheODT_CA pin shall be connected to either VDD2 or Vss.     |

### 3. Absolute Maximum DC Ratings

This chapter specifies absolute maximum DC ratings. Stresses greater than those listed may cause permanent damage to the device.

This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Table 3-1 Absolute Maximum DC Ratings

| Parameter                                         | Symbol                             | Min  | Max | Unit |
|---------------------------------------------------|------------------------------------|------|-----|------|
| VDD1 supply voltage relative to VSS <sup>1</sup>  | VDD1                               | -0.4 | 2.1 | V    |
| VDD2 supply voltage relative to VSS <sup>1</sup>  | VDD2                               | -0.4 | 1.5 |      |
| VDDQ supply voltage relative to VSSQ <sup>1</sup> | VDDQ                               |      |     |      |
| Voltage on any ball except VDD1 relative to VSS   | V <sub>IN</sub> , V <sub>OUT</sub> |      |     |      |
| Storage Temperature <sup>2</sup>                  | T <sub>STG</sub>                   | -55  | 125 | °C   |

**Note:**

- 1 See "Power-Ramp" for relationships between power supplies.
- 2 Storage temperature is the case surface temperature on the center/top side of the LPDDR4X device. For the measurement conditions, please refer to JESD51-2.

## 4. AC and DC Operating Conditions

This chapter points out four key conditions for low power device working reliably, safely and legally, which are DC operating voltage, input/output leakage current, temperature, single-ended and differential output slew rate.

- Recommended DC Operating Conditions for Low Voltage [on Page 18](#)
- Input Leakage Current [on Page 19](#)
- Input/Output Leakage Current [on Page 19](#)
- Operating Temperature Range [on Page 19](#)
- Single Ended Output Slew Rate [on Page 20](#)
- Differential Output Slew Rate [on Page 22](#)

## 4.1 Recommended DC Operating Conditions for Low Voltage

Table 4-1 LPDDR4X Recommended DC Operating Conditions

| DRAM                            | Symbol | Min  | Typ | Max  | Unit | Note    |
|---------------------------------|--------|------|-----|------|------|---------|
| Core 1 Power                    | VDD1   | 1.7  | 1.8 | 1.95 | V    | 1,2     |
| Core 1 Power/Input Buffer Power | VDD2   | 1.06 | 1.1 | 1.17 | V    | 1,2,3   |
| I/O Buffer Power                | VDDQ   | 0.57 | 0.6 | 0.65 | V    | 2,3,4,5 |

**Note:**

- VDD1 uses significantly less current than VDD2.
- The voltage range is for DC voltage only. DC is defined as the voltage supplied at the DRAM and is inclusive of all noise up to 20 MHz at the DRAM package ball.
- The voltage noise tolerance from DC to 20 MHz exceeding a pk-pk tolerance of 45 mV at the DRAM ball is not included in the TdIVW.
- VDDQ(max) may be extended to 0.67 V as an option in case the operating clock frequency is equal or less than 800 Mhz.
- Pull up, pull down and ZQ calibration tolerance spec is valid only in normal VDDQ tolerance range (0.57 V - 0.65 V).

## 4.2 Input Leakage Current

Table 4-2 Input Leakage Current

| Parameter/Condition                  | Symbol | Min | Max | Unit |
|--------------------------------------|--------|-----|-----|------|
| Input Leakage current <sup>1,2</sup> | $I_L$  | -4  | 4   | uA   |

**Note:**

- 1 For CK\_t, CK\_c, CKE, CS, CA, ODT\_CA and RESET\_n. Any input  $0V \leq V_{IN} \leq V_{DD2}$  (All other pins not under test = 0V).
- 2 CA ODT is disabled for CK\_t, CK\_c, CS, and CA.

## 4.3 Input/Output Leakage Current

Table 4-3 Input/Output Leakage Current

| Parameter/Condition                         | Symbol   | Min | Max | Unit |
|---------------------------------------------|----------|-----|-----|------|
| Input/Output Leakage current <sup>1,2</sup> | $I_{oz}$ | -5  | 5   | uA   |

**Note:**

- 1 For DQ, DQS\_t, DQS\_c and DMI. Any I/O  $0V \leq V_{OUT} \leq V_{DDQ}$ .
- 2 I/Os status are disabled: High Impedance and ODT Off.

## 4.4 Operating Temperature Range

Table 4-4 Operating Temperature Range

| Parameter/Condition | Parameter/Condition | Min | Max | Unit |
|---------------------|---------------------|-----|-----|------|
| Standard            | $T_{OPER}$          | -25 | 85  | °C   |

**Note:**

- 1 Operating Temperature is the case surface temperature on the center-top side of the LPDDR4 device. For the measurement conditions, please refer to JESD51-2.

## 4.5 Single Ended Output Slew Rate

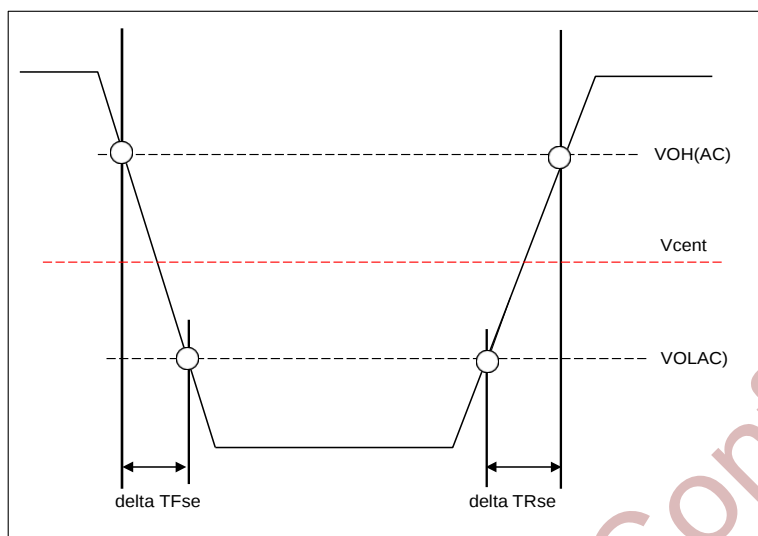


Figure 4-1 Single Ended Output Slew Rate Definition

Table 4-5 LPDDR4X Output Slew Rate (Single-ended) for 0.6V VDDQ

| Parameter                                                      | Symbol             | Value |     | Unit |
|----------------------------------------------------------------|--------------------|-------|-----|------|
|                                                                |                    | Min   | Max |      |
| Single-ended Output Slew Rate ( $V_{OH} = V_{DDQ} \cdot 0.5$ ) | SRQse <sup>a</sup> | 3.0   | 9   | V/ns |
| Output slew-rate matching Ratio (Rise to Fall)                 | -                  | 0.8   | 1.2 | -    |

<sup>a</sup>SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), se: Single-ended Signals

**Note:**

- 1 Measured with output reference load.
- 2 The ratio of pull-up to pull-down slew rate is specified for the same temperature and voltage, over the entire temperature and voltage range. For a given output, it represents the maximum difference between pull-up and pull-down drivers due to process variation.
- 3 The output slew rate for falling and rising edges is defined and measured between  $VOL(AC) = 0.2 \cdot V_{OH}(DC)$  and  $VOH(AC) = 0.8 \cdot V_{OH}(DC)$ .
- 4 Slew rates are measured under average SSO conditions, with 50% of DQ signals per data byte switching.

## 4.6 Differential Output Slew Rate

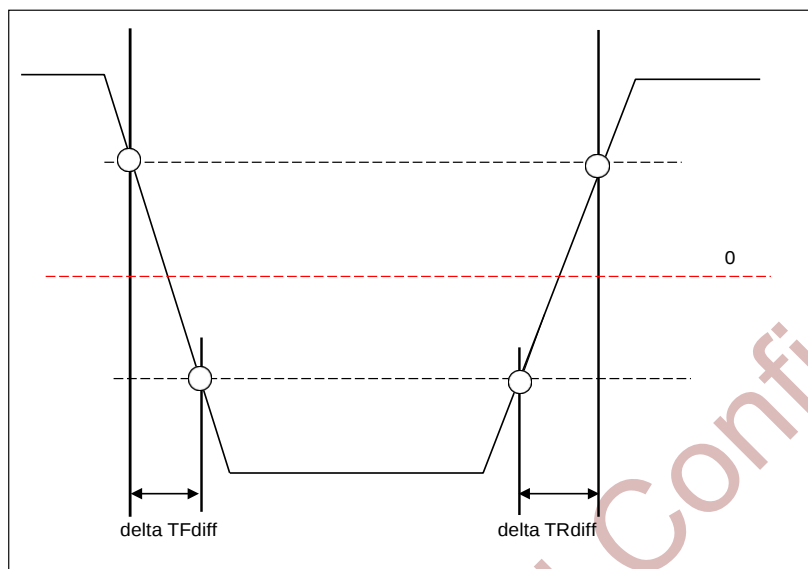


Figure 4-2 Differential Output Slew Rate Definition

Table 4-6 LPDDR4X Differential Output Slew Rate for 0.6V VDDQ

| Parameter                                                      | Symbol               | Value |     | Unit |
|----------------------------------------------------------------|----------------------|-------|-----|------|
|                                                                |                      | Min   | Max |      |
| Differential Output Slew Rate ( $V_{OH} = V_{DDQ} \cdot 0.5$ ) | SRQdiff <sup>a</sup> | 6     | 18  | V/ns |

<sup>a</sup>SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), diff: differential Signals

**Note:**

- 1 Measured with output reference load.
- 2 The output slew rate for falling and rising edges is defined and measured between  $V_{OL}(AC) = -0.8 \cdot V_{OH}(DC)$  and  $V_{OH}(AC) = 0.8 \cdot V_{OH}(DC)$ .
- 3 Slew rates are measured under average SSO conditions, with 50% of DQ signals per data byte switching.

## 5. AC and DC Input/Output Measurement Levels

This chapter mainly defines DC electrical characteristics for input signals, AC overshoot and undershoot specifications, differential input voltage specifications, and output driver to ensure the normal operation of LPDDR4X SDRAM.

- 1.1V High Speed LVCMOS (HS\_LLVC MOS) [on Page 24](#)
- Differential Input Voltage [on Page 26](#)
- Single-Ended Input Voltage for Clock [on Page 28](#)
- AC/DC Input level for ODT Input [on Page 39](#)
- Overshoot and Undershoot for LVSTL [on Page 40](#)
- Driver Output Timing Reference Load [on Page 40](#)
- LVSTL(Low Voltage Swing Terminated Logic) IO System [on Page 42](#)

## 5.1 1.1V High Speed LVCMOS (HS\_LLVC MOS)

### 5.1.1 Standard Specifications

All voltages are referenced to ground except where noted.

### 5.1.2 DC Electrical Characteristics

#### 5.1.2.1 Input Level for CKE

This definition applies to CKE\_A/ CKE\_B.

Table 5-1 Input Level for CKE

| Parameter                          | Symbol  | Min       | Max       | Unit |
|------------------------------------|---------|-----------|-----------|------|
| Input high level (AC) <sup>1</sup> | VIH(AC) | 0.75*VDD2 | VDD2+0.2  | V    |
| Input low level (AC) <sup>1</sup>  | VIL(AC) | -0.2      | 0.25*VDD2 | V    |
| Input high level (DC)              | VIH(DC) | 0.65*VDD2 | VDD2+0.2  | V    |
| Input low level (DC)               | VIL(DC) | -0.2      | 0.35*VDD2 | V    |

**Note:**

Refer AC Overshoot and Undershoot for VIH(AC) and VIL(AC)

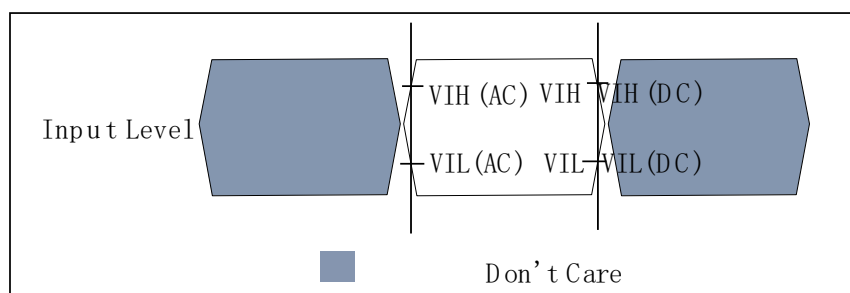


Figure 5-1 Input AC Timing Definition for CKE

**Note:**

- 1 AC level is guaranteed transition point.
- 2 DC level is hysteresis.

### 5.1.2.2 Input Level for Reset\_n and ODT\_CA

This definition applies to Reset\_n and ODT\_CA.

Table 5-2 Input Level for Reset\_n and ODT\_CA

| Parameter                     | Symbol | Min               | Max               | Unit |
|-------------------------------|--------|-------------------|-------------------|------|
| Input high level <sup>1</sup> | VIH    | $0.80 \cdot VDD2$ | $VDD2 + 0.2$      | V    |
| Input low level <sup>1</sup>  | VIL    | -0.2              | $0.20 \cdot VDD2$ | V    |

**Note:**

Refer AC Overshoot and Undershoot for VIH and VIL

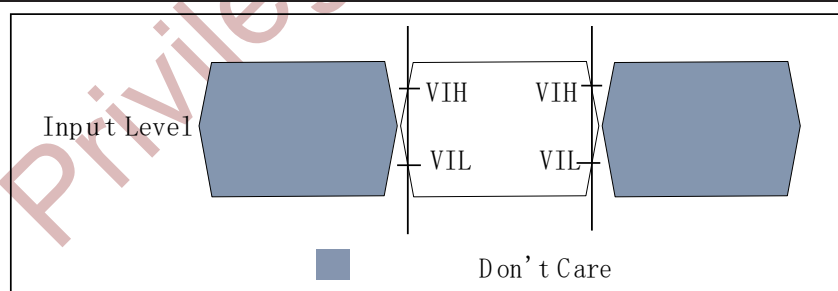


Figure 5-2 Input AC Timing Definition for Reset\_n and ODT\_CA

### 5.1.3 AC Overshoot and Undershoot

Table 5-3 AC Over/Undershoot for Address and Control Pins

| Parameter                                          | Specification |
|----------------------------------------------------|---------------|
| Maximum peak Amplitude allowed for overshoot area  | 0.35 V        |
| Maximum peak Amplitude allowed for undershoot area | 0.35 V        |
| Maximum overshoot area above VDD/VDDQ              | 0.8 V-ns      |
| Maximum undershoot area below VSS/VSSQ             | 0.8 V-ns      |

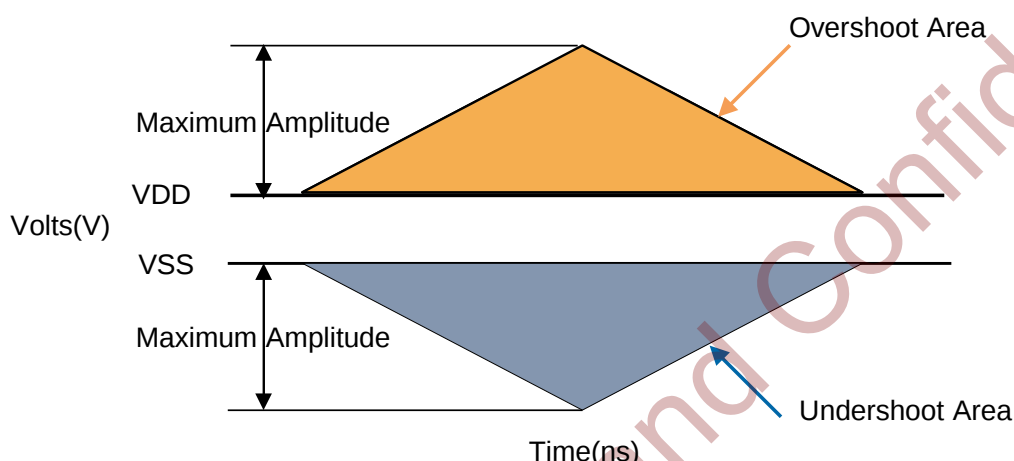


Figure 5-3 AC Overshoot and Undershoot Definition for Address and Control Pins

## 5.2 Differential Input Voltage

### 5.2.1 Differential Input Voltage for Clock

The minimum input voltage need to satisfy both Vindiff\_CK and Vindiff\_CK/2 specification at input receiver and their measurement period is 1tCK. Vindiff\_CK is the peak to peak voltage centered on 0 volts differential and Vindiff\_CK/2 is max and min peak voltage from 0V.

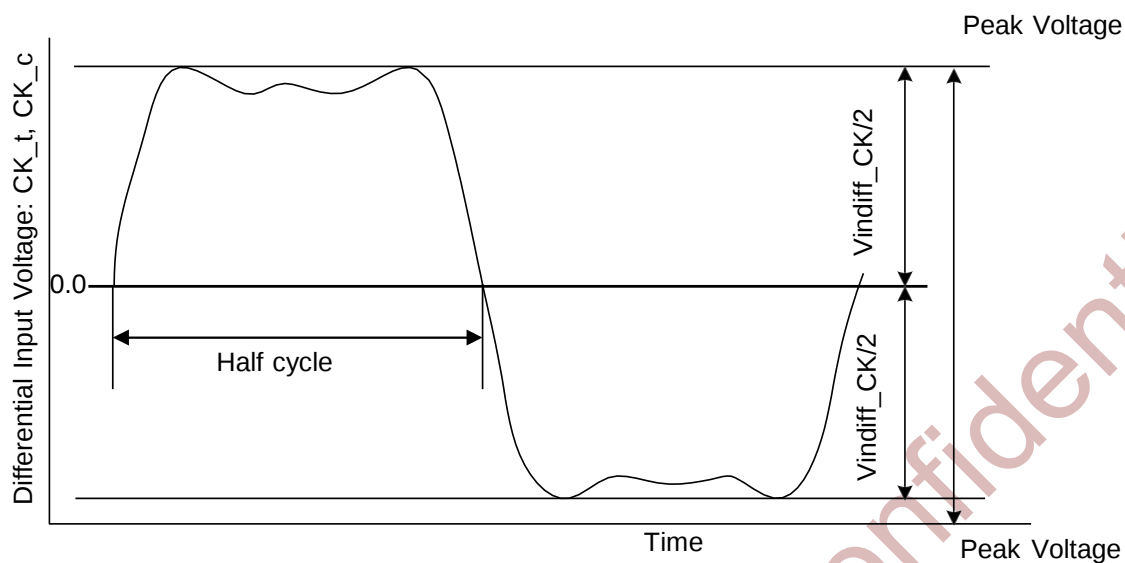


Figure 5-4 CK Differential Input Voltage

Table 5-4 CK Differential Input Voltage

| Parameter                                                                                                                                | Symbol     | Data Rate              |     |                |     |           |     | Unit |
|------------------------------------------------------------------------------------------------------------------------------------------|------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                                                                                                          |            | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                                                                                                          |            | Min                    | Max | Min            | Max | Min       | Max |      |
| CK differential input voltage                                                                                                            | Vindiff_CK | 420                    | -   | 380            | -   | 360       | -   | mV   |
| a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867. |            |                        |     |                |     |           |     |      |

**Note:**

The peak voltage of Differential CK signals is calculated in a following equation.

- $V_{indiff\_CK} = (\text{Max Peak Voltage}) - (\text{Min Peak Voltage})$
- $\text{Max Peak Voltage} = \text{Max}(f(t))$
- $\text{Min Peak Voltage} = \text{Min}(f(t))$
- $f(t) = V_{CK\_t} - V_{CK\_c}$

### 5.2.2 Peak Voltage Calculation Method

The peak voltage of Differential Clock signals is calculated in a following equation.

$$VIH.DIFF.Peak\ Voltage = \text{Max}(f(t))$$

$$VIL.DIFF.Peak\ Voltage = \text{Min}(f(t))$$

$$f(t) = VCK\_t - VCK\_c$$

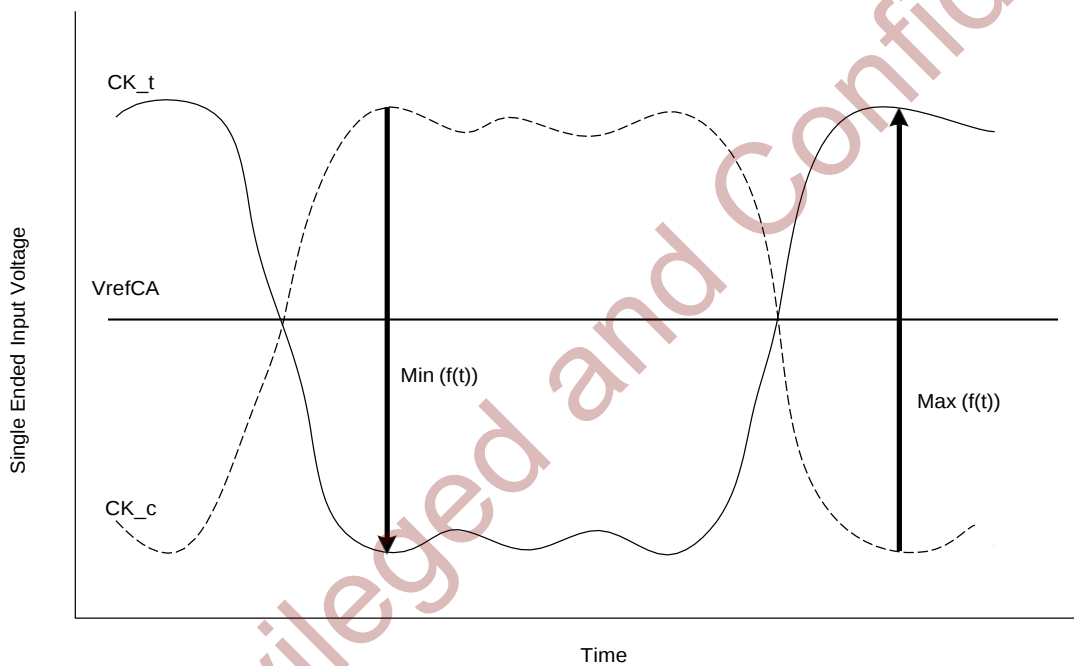


Figure 5-5 Definition of Differential Clock Peak Voltage

**Note:**  
VREFCA is LPDDR4X SDRAM internal setting value by VREF Training.

### 5.3 Single-Ended Input Voltage for Clock

The minimum input voltage need to satisfy both Vinse\_CK, Vinse\_CK\_High/Low specification at input receiver.

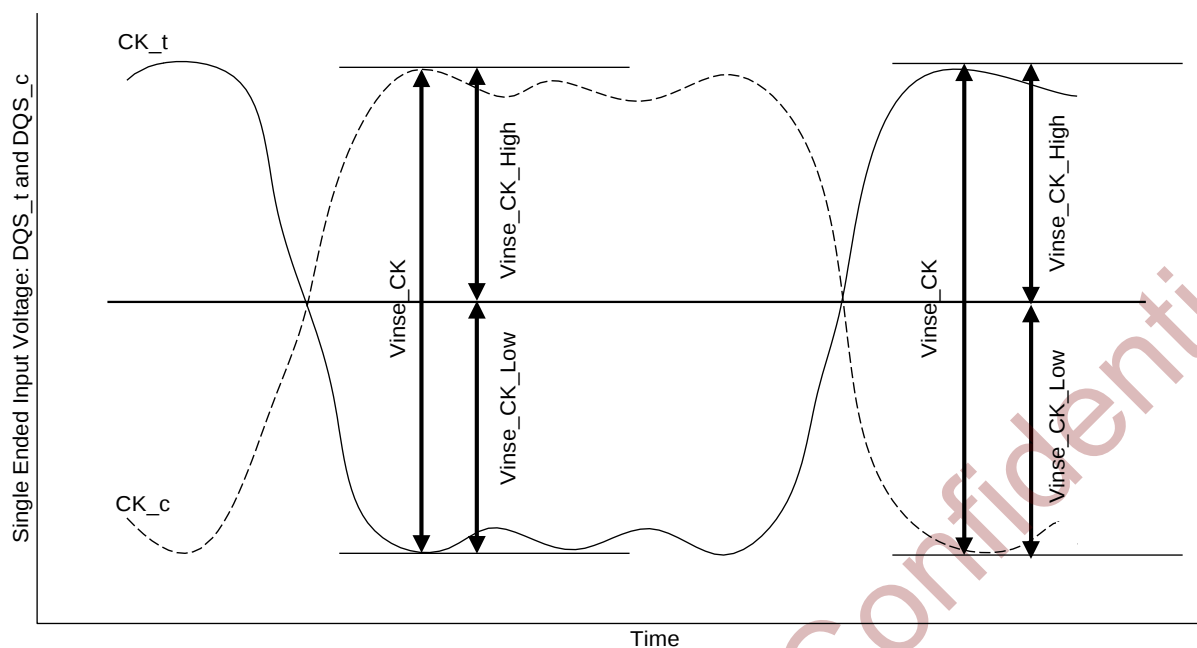


Figure 5-6 Clock Single-Ended Input Voltage

**Note:**

VREFCA is LPDDR4X SDRAM internal setting value by VREF Training.

Table 5-5 Clock Single-Ended Input Voltage

| Parameter                                                      | Symbol        | Data Rate              |     |                |     |           |     | Unit |
|----------------------------------------------------------------|---------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                                |               | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                                |               | Min                    | Max | Min            | Max | Min       | Max |      |
| Clock Single-Ended input voltage                               | Vinse_CK      | 210                    | -   | 190            | -   | 180       | -   | mV   |
| Clock Single-Ended input voltage High from V <sub>REF</sub> DQ | Vinse_CK_High | 105                    | -   | 95             | -   | 90        | -   | mV   |
| Clock Single-Ended input voltage Low from V <sub>REF</sub> DQ  | Vinse_CK_Low  | 105                    | -   | 95             | -   | 90        | -   | mV   |

a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867.

### 5.3.2.1 Differential Input Slew Rate Definition for Clock

Input slew rate for differential signals (CK\_t, CK\_c) are defined and measured as shown in Figure 5-7 and the following Tables.

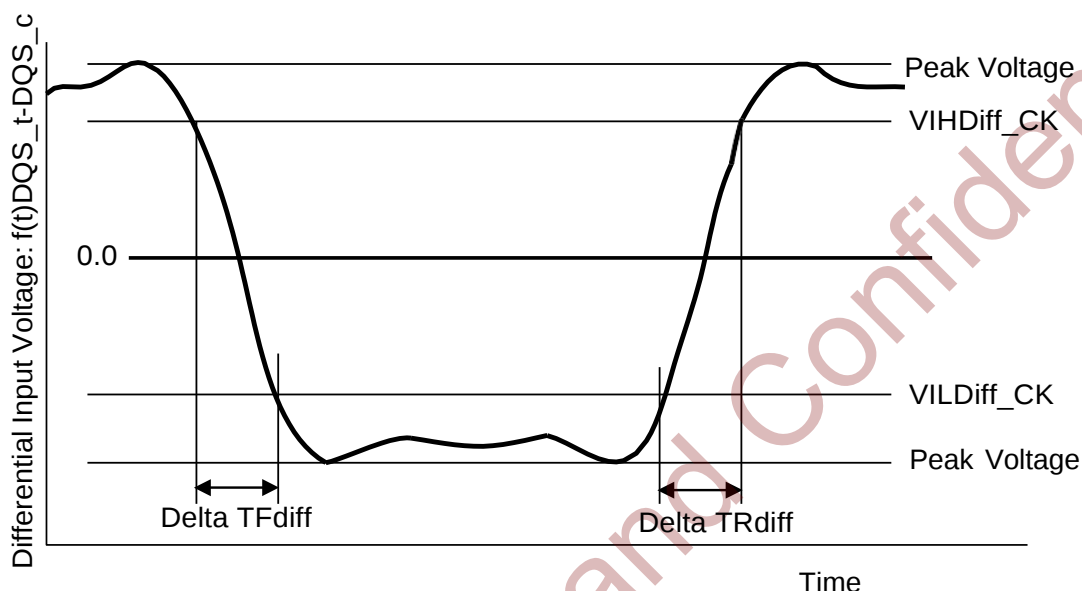


Figure 5-7 Differential Input Slew Rate Definition for CK\_t, CK\_c

**Note:**

- 1 Differential signal rising edge from VILdiff\_CK to VIHdiff\_CK must be monotonic slope.
- 2 Differential signal falling edge from VIHdiff\_CK to VILdiff\_CK must be monotonic slope.

Table 5-6 Differential Input Slew Rate Definition for CK\_t, CK\_c

| Description                                                | From       | To         | Defined by                                  |
|------------------------------------------------------------|------------|------------|---------------------------------------------|
| Differential input slew rate for rising edge(CK_t - CK_c)  | VILdiff_CK | VIHdiff_CK | $ VILdiff\_CK - VIHdiff\_CK /\Delta TRdiff$ |
| Differential input slew rate for falling edge(CK_t - CK_c) | VIHdiff_CK | VILdiff_CK | $ VILdiff\_CK - VIHdiff\_CK /\Delta TFdiff$ |

Table 5-7 Differential Input Level for CK\_t, CK\_c

| Parameter               | Symbol     | Data Rate              |      |                |      |           |      | Unit |
|-------------------------|------------|------------------------|------|----------------|------|-----------|------|------|
|                         |            | 1600/1867 <sup>a</sup> |      | 2133/2400/3200 |      | 3733/4266 |      |      |
|                         |            | Min                    | Max  | Min            | Max  | Min       | Max  |      |
| Differential Input High | VIHdiff_CK | 175                    | -    | 155            | -    | 145       | -    | mV   |
| Differential Input Low  | VILdiff_CK | -                      | -175 | -              | -155 | -         | -145 | mV   |

a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867.

Table 5-8 Differential Input Slew Rate for CK\_t, CK\_c

| Parameter                                                                                                                                | Symbol     | Data Rate              |     |                |     |           |     | Unit |
|------------------------------------------------------------------------------------------------------------------------------------------|------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                                                                                                          |            | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                                                                                                          |            | Min                    | Max | Min            | Max | Min       | Max |      |
| Differential Input Slew Rate for Clock                                                                                                   | SRIdiff_CK | 2                      | 14  | 2              | 14  | 2         | 14  | V/ns |
| a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867. |            |                        |     |                |     |           |     |      |

### 5.3.2.2 Differential Input Cross Point Voltage

The cross point voltage of differential input signals (CK\_t, CK\_c) must meet the requirements in Table 5-8. The differential input cross point voltage VIX is measured from the actual cross point of true and complement signals to the mid level that is VREFCA.

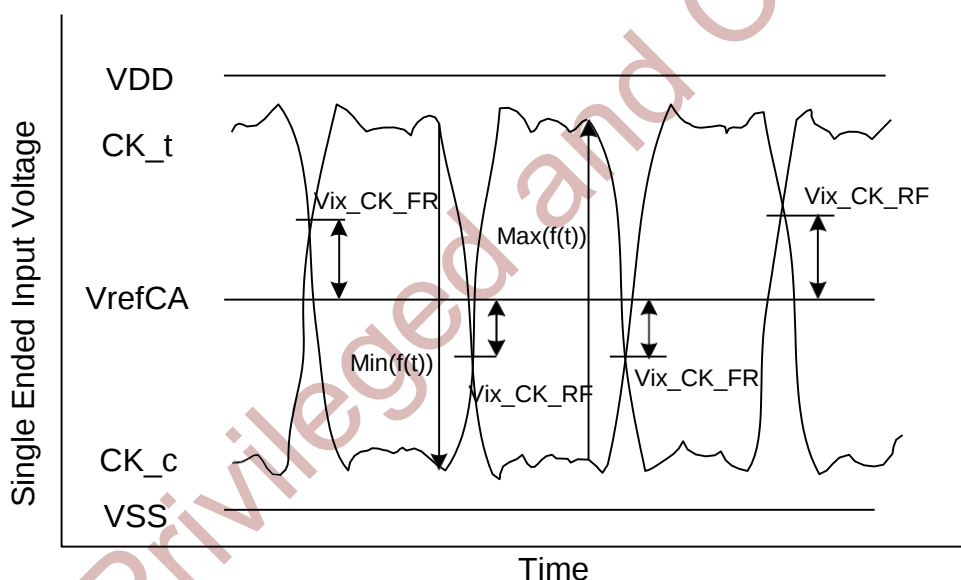


Figure 5-8 Vix Definition (Clock)

#### Note:

The base level of Vix\_CK\_FR/RF is VREFCA that is LPDDR4X SDRAM internal setting value by VREF Training.

Table 5-9 Cross Point Voltage for Differential Input Signals (Clock)

| Parameter                                                                                                                                | Symbol       | Data Rate              |     |                |     |           |     | Unit |
|------------------------------------------------------------------------------------------------------------------------------------------|--------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                                                                                                          |              | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                                                                                                          |              | Min                    | Max | Min            | Max | Min       | Max |      |
| Clock Differential input cross point voltage ratio <sup>1,2</sup>                                                                        | Vix_CK_ratio | -                      | 25  | -              | 25  | -         | 25  | %    |
| a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867. |              |                        |     |                |     |           |     |      |

**Note:**

- 1 Vix\_CK\_Ratio is defined by this equation:  $Vix\_CK\_Ratio = Vix\_CK\_FR / |\text{Min}(f(t))|$
- 2 Vix\_CK\_Ratio is defined by this equation:  $Vix\_CK\_Ratio = Vix\_CK\_RF / \text{Max}(f(t))$

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### 5.3.2.3 Differential Input Voltage for DQS

The minimum input voltage need to satisfy both  $V_{\text{indiff\_DQS}}$  and  $V_{\text{indiff\_DQS}}/2$  specification at input receiver and their measurement period is  $1UI(t_{\text{CK}}/2)$ .  $V_{\text{indiff\_DQS}}$  is the peak to peak voltage centered on 0 volts differential and  $V_{\text{indiff\_DQS}}/2$  is max and min peak voltage from 0V.

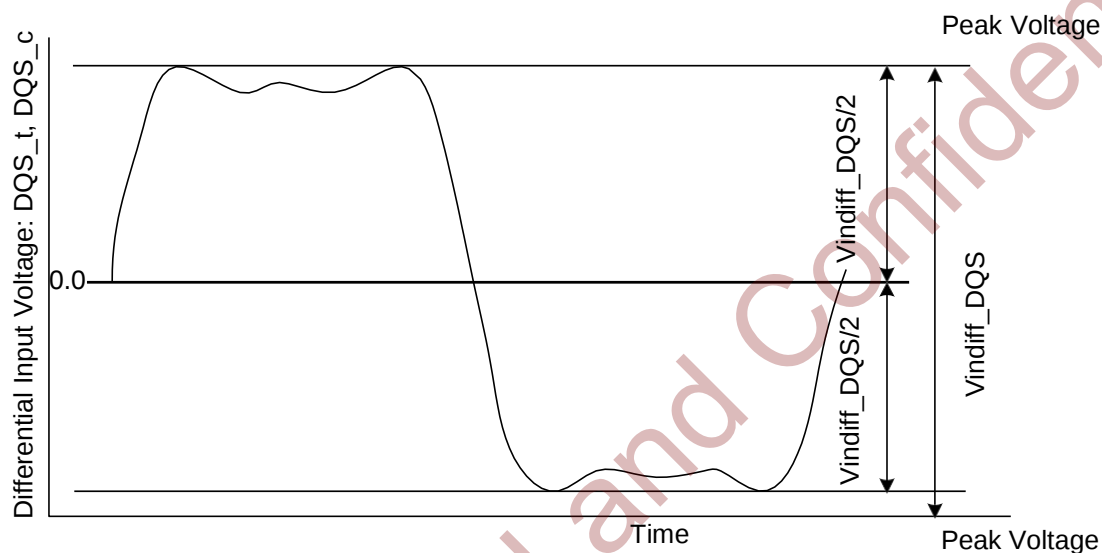


Figure 5-9 DQS Differential Input Voltage

Table 5-10 DQS Differential Input Voltage

| Parameter                           | Symbol      | Data Rate              |     |                |     |           |     | Unit |
|-------------------------------------|-------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                     |             | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                     |             | Min                    | Max | Min            | Max | Min       | Max |      |
| DQS differential input <sup>1</sup> | Vindiff_DQS | 360                    | -   | 360            | -   | 340       | -   | mV   |

a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867.

**Note:**

1 The peak voltage of Differential DQS signals is calculated in a following equation.

- $V_{indiff\_DQS} = (\text{Max Peak Voltage}) - (\text{Min Peak Voltage})$
- $\text{Max Peak Voltage} = \text{Max}(f(t))$
- $\text{Min Peak Voltage} = \text{Min}(f(t))$
- $f(t) = VDQS\_t - VDQS\_c$

### 5.3.2.4 Peak Voltage Calculation Method

The peak voltage of Differential DQS signals are calculated in a following equation.

- $V_{IH.DIFF.Peak Voltage} = \text{Max}(f(t))$
- $V_{IL.DIFF.Peak Voltage} = \text{Min}(f(t))$
- $f(t) = VDQS\_t - VDQS\_c$

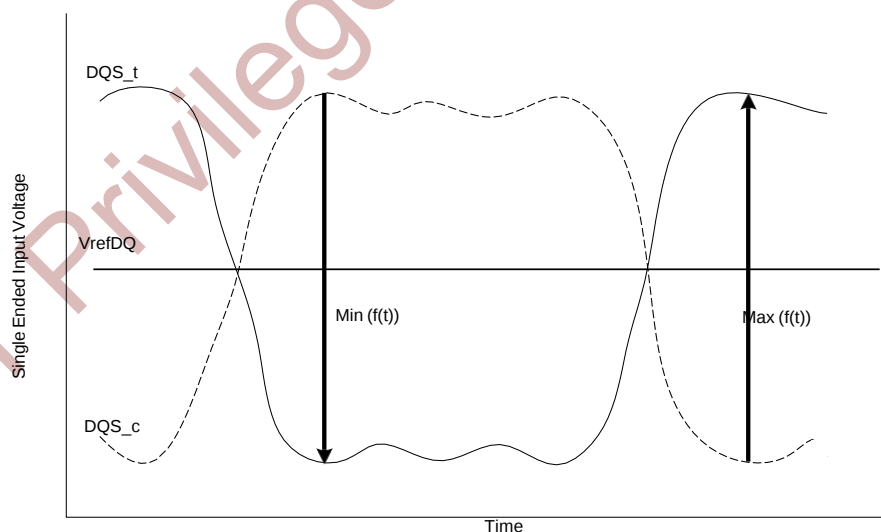


Figure 5-10 Definition of Differential DQS Peak Voltage

**Note:**

VrefDQ is LPDDR4X SDRAM internal setting value by Vref Training.

### 5.3.2.5 Single-Ended Input Voltage for DQS

The minimum input voltage need to satisfy both  $V_{inse\_DQS}$ ,  $V_{inse\_DQS\_High/Low}$  specification at input receiver.

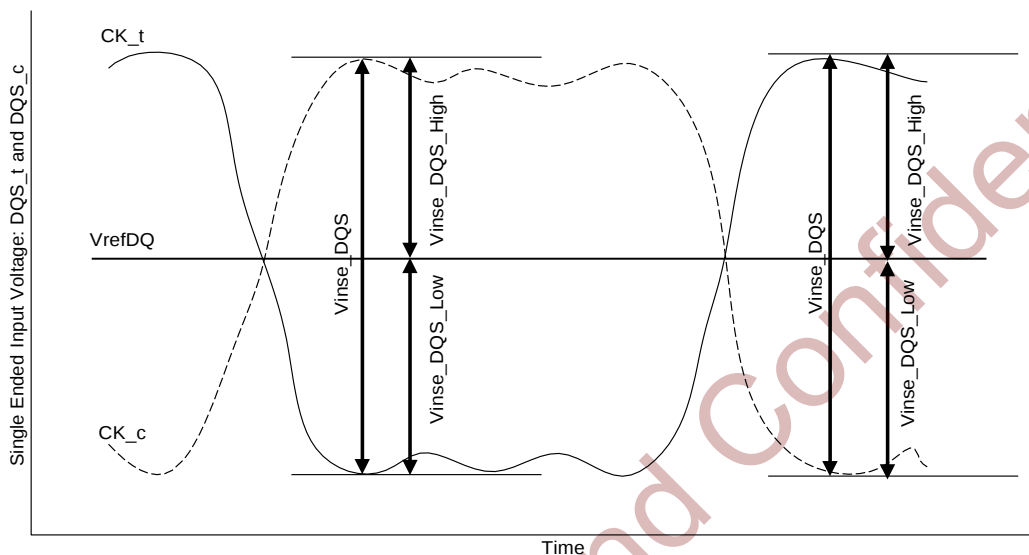


Figure 5-11 DQS Single-Ended Input Voltage

**Note:**

$V_{refDQ}$  is LPDDR4X SDRAM internal setting value by  $V_{ref}$  Training.

Table 5-11 DQS Single-Ended Input Voltage

| Parameter                                                     | Symbol         | Data Rate              |     |                |     |           |     | Unit |
|---------------------------------------------------------------|----------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                               |                | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                               |                | Min                    | Max | Min            | Max | Min       | Max |      |
| DQS Single-Ended input voltage                                | Vindiff_DQS    | 180                    | -   | 180            | -   | 170       | -   | mV   |
| DQS Single-Ended input voltage High from V <sub>REF</sub> _DQ | Vinse_DQS_High | 90                     | -   | 90             | -   | 85        | -   | mV   |
| DQS Single-Ended input voltage Low from V <sub>REF</sub> _DQ  | Vinse_DQS_Low  | 90                     | -   | 90             | -   | 85        | -   | mV   |

a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867.

### 5.3.2.6 Differential Input Slew Rate Definition for DQS

Input slew rate for differential signals (DQS<sub>t</sub>, DQS<sub>c</sub>) are defined and measured as shown below.

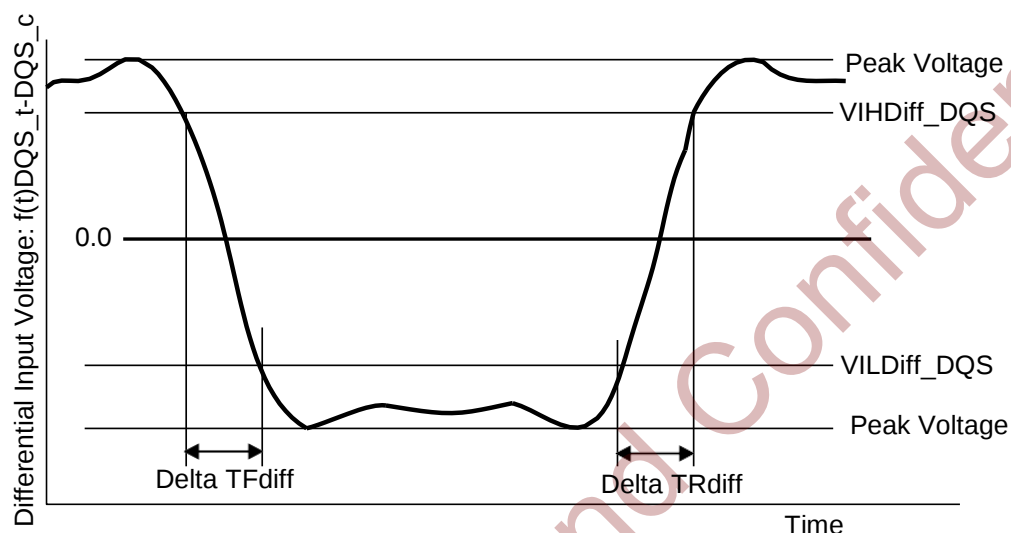


Figure 5-12 Differential Input Slew Rate Definition for DQS<sub>t</sub>, DQS<sub>c</sub>

**Note:**

- 1 Differential signal rising edge from VILdiff\_DQS to VIHdiff\_DQS must be monotonic slope.
- 2 Differential signal falling edge from VIHdiff\_DQS to VILdiff\_DQS must be monotonic slope.

Table 5-12 Differential Input Slew Rate Definition for DQS<sub>t</sub>, DQS<sub>c</sub>

| Description                                                                         | From        | To          | Defined by                                    |
|-------------------------------------------------------------------------------------|-------------|-------------|-----------------------------------------------|
| Differential input slew rate for rising edge(DQS <sub>t</sub> - DQS <sub>c</sub> )  | VIHdiff_DQS | VIHdiff_DQS | $ VILdiff\_DQS - VIHdiff\_DQS /\Delta TRdiff$ |
| Differential input slew rate for falling edge(DQS <sub>t</sub> - DQS <sub>c</sub> ) | VIHdiff_DQS | VIHdiff_DQS | $ VILdiff\_DQS - VIHdiff\_DQS /\Delta TFdiff$ |

Table 5-13 Differential Input Level for DQS<sub>t</sub>, DQS<sub>c</sub>

| Parameter               | Symbol      | Data Rate              |      |                |      |           |      | Unit |
|-------------------------|-------------|------------------------|------|----------------|------|-----------|------|------|
|                         |             | 1600/1867 <sup>a</sup> |      | 2133/2400/3200 |      | 3733/4266 |      |      |
|                         |             | Min                    | Max  | Min            | Max  | Min       | Max  |      |
| Differential Input High | VIHdiff_DQS | 140                    | -    | 140            | -    | 120       | -    | mV   |
| Differential Input Low  | VILdiff_DQS | -                      | -140 | -              | -140 | -         | -120 | mV   |

a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867.

Table 5-14 Differential Input Slew Rate for DQS<sub>t</sub>, DQS<sub>c</sub>

| Parameter                    | Symbol  | Data Rate              |     |                |     |           |     | Unit |
|------------------------------|---------|------------------------|-----|----------------|-----|-----------|-----|------|
|                              |         | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                              |         | Min                    | Max | Min            | Max | Min       | Max |      |
| Differential Input Slew Rate | SRIdiff | 2                      | 14  | 2              | 14  | 2         | 14  | V/ns |

### 5.3.2.7 Differential Input Cross Point Voltage

The cross point voltage of differential input signals (DQS<sub>t</sub>, DQS<sub>c</sub>) must meet the requirements in Table 5-13.

The differential input cross point voltage VIX is measured from the actual cross point of true and complement signals to the mid level that is VREFDQ.

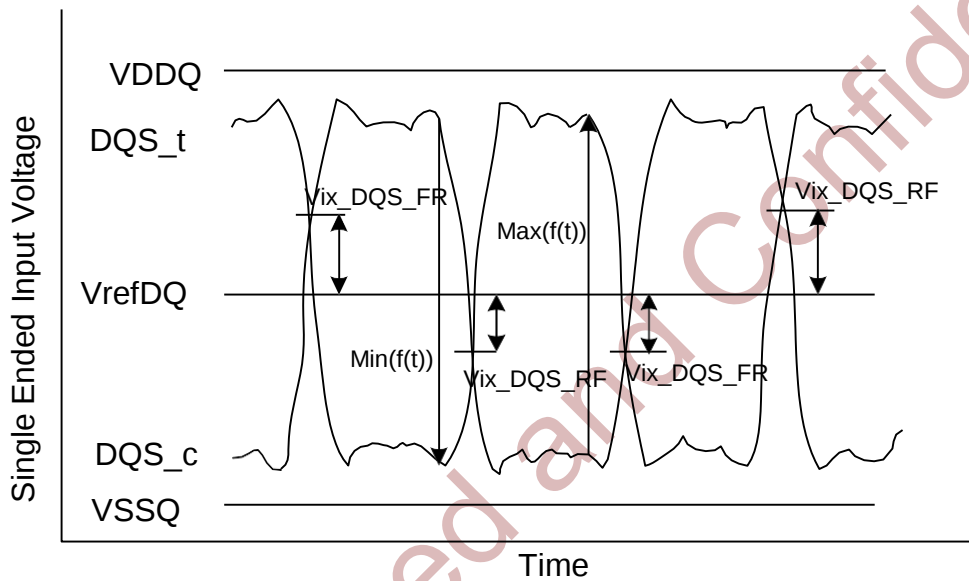


Figure 5-13 Vix Definition (DQS)

**Note:**  
The base level of Vix\_DQS\_FR/RF is VrefDQ that is LPDDR4X SDRAM internal setting value by Vref Training.

Table 5-15 Cross Point Voltage for Differential Input Signals (DQS)

| Parameter                                                                                                                                | Symbol        | Data Rate              |     |                |     |           |     | Unit |
|------------------------------------------------------------------------------------------------------------------------------------------|---------------|------------------------|-----|----------------|-----|-----------|-----|------|
|                                                                                                                                          |               | 1600/1867 <sup>a</sup> |     | 2133/2400/3200 |     | 3733/4266 |     |      |
|                                                                                                                                          |               | Min                    | Max | Min            | Max | Min       | Max |      |
| DQS Differential input cross point voltage ratio <sup>1,2</sup>                                                                          | Vix_DQS_ratio | -                      | 20  | -              | 20  | -         | 20  | %    |
| a. The following requirements apply for DQ operating frequencies at or below 1333Mbps for all speed bins for the first column 1600/1867. |               |                        |     |                |     |           |     |      |

**Note:**

- 1 Vix\_DQS\_Ratio is defined by this equation:  $Vix\_DQS\_Ratio = Vix\_DQS\_FR / |Min(f(t))|$ .
- 2 Vix\_DQS\_Ratio is defined by this equation:  $Vix\_DQS\_Ratio = Vix\_DQS\_RF / Max(f(t))$ .

## 5.4 AC/DC Input level for ODT Input

Table 5-16 Input Level for ODT

| Parameter                              | Symbol     | Min      | Max      | Unit |
|----------------------------------------|------------|----------|----------|------|
| ODT Input High Level (AC) <sup>1</sup> | VIHODT(AC) | 0.75*VDD | VDD+0.2  | V    |
| ODT Input Low Level (AC) <sup>1</sup>  | VILODT(AC) | -0.2     | 0.25*VDD | V    |
| ODT Input High Level (DC)              | VIHODT(DC) | 0.65*VDD | VDD+0.2  | V    |
| ODT Input Low Level (DC)               | VILODT(DC) | -0.2     | 0.35*VDD | V    |

**Note:**

See Overshoot and Undershoot Specifications

## 5.5 Overshoot and Undershoot for LVSTL

Table 5-17 AC Overshoot/Undershoot Specification

| Parameter                                                                           | Min/Max | Data Rate      |      | Unit |
|-------------------------------------------------------------------------------------|---------|----------------|------|------|
|                                                                                     |         | 1600/1866/3200 | 4266 |      |
| Maximum peak amplitude allowed for overshoot area. See <a href="#">Figure 5-16</a>  | Max     | 0.3            | TBD  | V    |
| Maximum peak amplitude allowed for undershoot area. See <a href="#">Figure 5-16</a> | Max     | 0.3            | TBD  | V    |
| Maximum area above VDD. See <a href="#">Figure 5-16</a>                             | Max     | 0.1            | TBD  | V/ns |
| Maximum area below VSS. See <a href="#">Figure 5-16</a>                             | Max     | 0.1            | TBD  | V/ns |

**Note:**

- 1 VDD2 stands for VDD for CA[5:0], CK\_t, CK\_c, CS\_n, CKE and ODT. VDD stands for VDDQ for DQ, DMI, DQS\_t and DQS\_c.
- 2 VSS stands for VSS for CA[5:0], CK\_t, CK\_c, CS\_n, CKE and ODT. VSS stands for VSSQ for DQ, DMI, DQS\_t and DQS\_c.
- 3 Maximum peak amplitude values are referenced from actual VDD and VSS values.
- 4 Maximum area values are referenced from maximum operating VDD and VSS values.

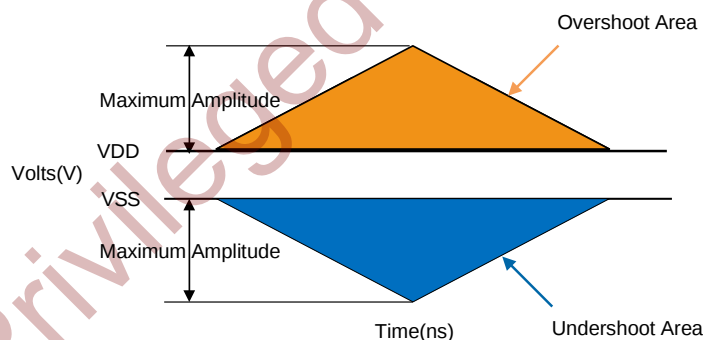


Figure 5-14 Overshoot and Undershoot Definition

## 5.6 Driver Output Timing Reference Load

These 'Timing Reference Loads' are not intended as a precise representation of any particular system environment or a depiction of the actual load presented by a production tester. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. Manufacturers correlate to their production test conditions, generally one or more coaxial transmission lines terminated at the tester electronics.

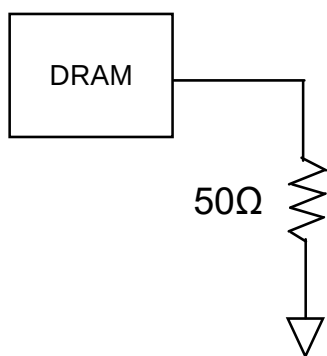


Figure 5-15 Driver Output Reference Load for Timing and Slew Rate

**Note:**

All output timing parameter values are reported with respect to this reference load. This reference load is also used to report slew rate.

## 5.7 LVSTL(Low Voltage Swing Terminated Logic) IO System

LVSTL I/O cell is comprised of pull-up, pull-down driver and a terminator. The basic cell is shown in Figure 5-16.

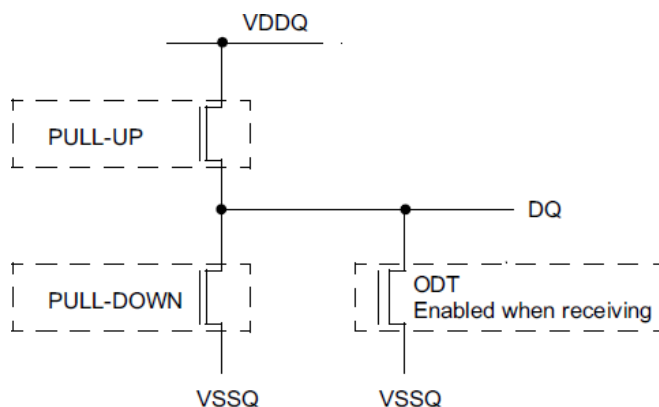


Figure 5-16 LVSTL I/O Cell

To ensure that the target impedance is achieved the LVSTL I/O cell is designed to calibrated as below procedure.

First calibrate the pull-down device against a 240  $\Omega$  resistor to VDDQ via the ZQ pin.

- Set Strength Control to minimum setting.
- Increase drive strength until comparator detects data bit is less than  $VDDQ/2$ .
- NMOS pull-down device is calibrated to 240  $\Omega$ .

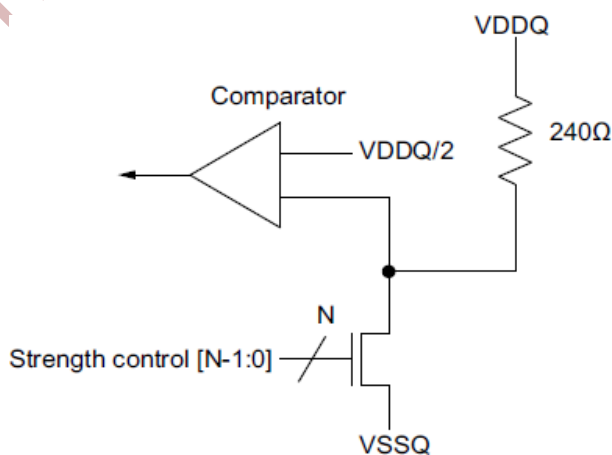


Figure 5-17 Pull-down Calibration

Then calibrate the pull-up device against the calibrated pull-down device.

- Set VOH target and NMOS controller ODT replica via MRS (VOH can be automatically controlled by ODT MRS).
- Set Strength Control to minimum setting.
- Increase drive strength until comparator detects data bit is greater than VOH target.
- NMOS pull-up device is now calibrated to VOH target.

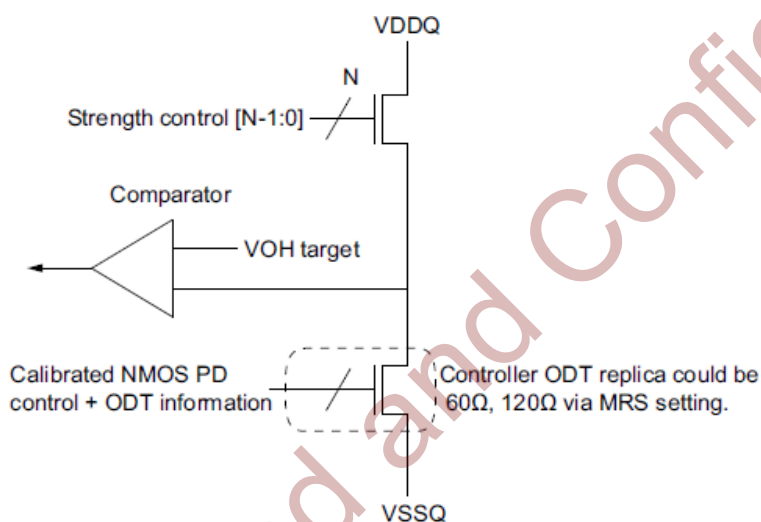


Figure 5-18 Pull-up Calibration

## 6. Input/Output Capacitance

Table 6-1 Input/output Capacitance

| Parameter                                          | Symbol            | Min/Max | 3200 - 533 | 4266-3733 | Unit | Note  |
|----------------------------------------------------|-------------------|---------|------------|-----------|------|-------|
| Input capacitance, CK_t and CK_c                   | C <sub>CK</sub>   | Min     | 0.5        | TBD       | pF   | 1,2   |
|                                                    |                   | Max     | 0.9        | TBD       |      |       |
| Input capacitance delta, CK_t and CK_c             | C <sub>DCK</sub>  | Min     | 0.0        | TBD       | pF   | 1,2,3 |
|                                                    |                   | Max     | 0.09       | TBD       |      |       |
| Input capacitance, all other input-only pins       | C <sub>I</sub>    | Min     | 0.5        | TBD       | pF   | 1,2,4 |
|                                                    |                   | Max     | 0.9        | TBD       |      |       |
| Input capacitance delta, all other input-only pins | C <sub>DI</sub>   | Min     | -0.1       | TBD       | pF   | 1,2,5 |
|                                                    |                   | Max     | 0.1        | TBD       |      |       |
| Input/output capacitance, DQ, DMI, DQS_t, DQS_c    | C <sub>IO</sub>   | Min     | 0.7        | TBD       | pF   | 1,2,6 |
|                                                    |                   | Max     | 1.3        | TBD       |      |       |
| Input/output capacitance delta, DQS_t, DQS_c       | C <sub>DDQS</sub> | Min     | 0.0        | TBD       | pF   | 1,2,7 |
|                                                    |                   | Max     | 0.1        | TBD       |      |       |
| Input/output capacitance delta, DQ, DMI            | C <sub>DIO</sub>  | Min     | -0.1       | TBD       | pF   | 1,2,8 |
|                                                    |                   | Max     | 0.1        | TBD       |      |       |
| Input/output capacitance, ZQ pin                   | C <sub>ZQ</sub>   | Min     | 0.0        | TBD       | pF   | 1,2   |
|                                                    |                   | Max     | 5.0        | TBD       |      |       |

**Note:**

- 1 This parameter applies to die device only (does not include package capacitance).
- 2 This parameter is not subject to production test. It is verified by design and characterization. The capacitance is measured according to JEP147 (Procedure for measuring input capacitance using a vector network analyzer (VNA) with VDD1, VDD2, VDDQ, VSS, VSSQ applied and all other pins floating).
- 3 Absolute value of CCK\_t . CCK\_c.
- 4 CI applies to CS\_n, CKE, CA0-CA5.
- 5  $CDI = CI \cdot 0.5 \cdot (CCK\_t + CCK\_c)$ .
- 6 DMI loading matches DQ and DQS.
- 7 Absolute value of CDQS\_t and CDQS\_c.
- 8  $CDIO = CIO \cdot 0.5 \cdot (CDQS\_t + CDQS\_c)$  in byte-lane.

## 7. IDD Test Conditions and Specifications

In this chapter, IDD measurement conditions including CA patterns and DQ patterns are defined. The key performance indicator IDD values are introduced in the second section of this chapter.

- IDD Measurement Conditions [on Page 46](#)
- IDD Specifications [on Page 53](#)

## 7.1 IDD Measurement Conditions

The following definitions are used within the IDD measurement tables unless stated otherwise:

LOW:  $V_{IN} \leq V_{IL}(DC) \text{ MAX}$

HIGH:  $V_{IN} \geq V_{IH}(DC) \text{ MIN}$

STABLE: Inputs are stable at a HIGH or LOW level

SWITCHING: See [Table 7-1](#) and [Table 7-2](#).

Table 7-1 Definition of Switching for CA Input Signals

| Switching for CA |      |      |      |      |      |      |      |      |
|------------------|------|------|------|------|------|------|------|------|
| CK_t Edge        | R1   | R2   | R3   | R4   | R5   | R6   | R7   | R8   |
| CKE              | HIGH | HIGH | HIGH | HIGH | HIGH | HIGH | HIGH | HIGH |
| CS               | LOW  | LOW  | LOW  | LOW  | LOW  | LOW  | LOW  | LOW  |
| CA0              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |
| CA1              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |
| CA2              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |
| CA3              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |
| CA4              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |
| CA5              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |

**Note:**

- 1 CS must always be driven LOW.
- 2 50% of CA bus is changing between HIGH and LOW once per clock for the CA bus.
- 3 The pattern is used continuously during IDD measurement for IDD values that require switching on the CA bus.

Table 7-2 CA Pattern for IDD4R

| Clock Cycle Number | CKE  | CS   | Com-<br>mand | CA0 | CA1 | CA2 | CA3 | CA4 | CA5 |
|--------------------|------|------|--------------|-----|-----|-----|-----|-----|-----|
| N                  | HIGH | HIGH | Read-1       | L   | H   | L   | L   | L   | L   |
| N+1                | HIGH | LOW  |              | L   | H   | L   | L   | L   | L   |
| N+2                | HIGH | HIGH | CAS-2        | L   | H   | L   | L   | H   | L   |
| N+3                | HIGH | LOW  |              | L   | L   | L   | L   | L   | L   |
| N+4                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+5                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+6                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+7                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+8                | HIGH | HIGH | Read-1       | L   | H   | L   | L   | L   | L   |
| N+9                | HIGH | LOW  |              | L   | H   | L   | L   | H   | L   |
| N+10               | HIGH | HIGH | CAS-2        | L   | H   | L   | L   | H   | H   |
| N+11               | HIGH | LOW  |              | H   | H   | H   | H   | H   | H   |
| N+12               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+13               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+14               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+15               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |

**Note:**

1 BA[2:0] = 010, CA[9:4] = 000000 or 111111, Burst Order CA[3:2] = 00 or 11 (Same as LPDDR3 IDD4R).

2 Difference from LPDDR3 (JESD209-3): CA pins are kept low with DES CMD to reduce ODT current.

Table 7-3 CA Pattern for IDD4W

| Clock Cycle Number | CKE  | CS   | Com-<br>mand | CA0 | CA1 | CA2 | CA3 | CA4 | CA5 |
|--------------------|------|------|--------------|-----|-----|-----|-----|-----|-----|
| N                  | HIGH | HIGH | Write-1      | L   | L   | H   | L   | L   | L   |
| N+1                | HIGH | LOW  |              | L   | H   | L   | L   | L   | L   |
| N+2                | HIGH | HIGH | CAS-2        | L   | H   | L   | L   | H   | L   |
| N+3                | HIGH | LOW  |              | L   | L   | L   | L   | L   | L   |
| N+4                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+5                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+6                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+7                | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+8                | HIGH | HIGH | Write-1      | L   | L   | H   | L   | L   | L   |
| N+9                | HIGH | LOW  |              | L   | H   | L   | L   | H   | L   |
| N+10               | HIGH | HIGH | CAS-2        | L   | H   | L   | L   | H   | H   |
| N+11               | HIGH | LOW  |              | L   | L   | H   | H   | H   | H   |
| N+12               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+13               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+14               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |
| N+15               | HIGH | LOW  | DES          | L   | L   | L   | L   | L   | L   |

**Note:**

1 BA[2:0] = 010, CA[9:4] = 000000 or 111111 (Same as LPDDR3 IDD4W).

2 Difference from LPDDR3 (JESD209-3): 1)-No burst ordering, and 2) CA pins are kept low with DES CMD to reduce ODT current.

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Table 7-4 Data Pattern for IDD4W (DBI off)

| DBI OFF Case |       |       |       |       |       |       |       |       |     | No. of 1's |
|--------------|-------|-------|-------|-------|-------|-------|-------|-------|-----|------------|
|              | DQ[7] | DQ[6] | DQ[5] | DQ[4] | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI |            |
| BL0          | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL1          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2          | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3          | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4          | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5          | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6          | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL7          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8          | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL9          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL15         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL16         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL17         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL19         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL21         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL22         | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL23         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL24         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL25         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL27         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28         | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL29         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL30         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL31         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| No. of 1's   | 16    | 16    | 16    | 16    | 16    | 16    | 16    | 16    |     |            |

**Note:**

Simplified pattern compared predecessor. Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming.

Table 7-5 Data Pattern for IDD4R (DBI off)

| DBI OFF Case |       |       |       |       |       |       |       |       |     | No. of 1's |
|--------------|-------|-------|-------|-------|-------|-------|-------|-------|-----|------------|
|              | DQ[7] | DQ[6] | DQ[5] | DQ[4] | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI |            |
| BL0          | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL1          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2          | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3          | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4          | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5          | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6          | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 6          |
| BL7          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8          | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL9          | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL15         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL16         | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL17         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL19         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL21         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL22         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL23         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL24         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 0          |
| BL25         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26         | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 1     | 0   | 8          |
| BL27         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL29         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL30         | 1     | 1     | 1     | 1     | 1     | 1     | 0     | 0     | 0   | 6          |
| BL31         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| No. of 1's   | 16    | 16    | 16    | 16    | 16    | 16    | 16    | 16    | 16  |            |

**Note:**

Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming

Table 7-6 Data Pattern for IDD4W (DBI On)

| DBI ON Case |       |       |       |       |       |       |       |       |     | No. of 1's |
|-------------|-------|-------|-------|-------|-------|-------|-------|-------|-----|------------|
|             | DQ[7] | DQ[6] | DQ[5] | DQ[4] | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI |            |
| BL0         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 1   | 1          |
| BL1         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL7         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 1          |
| BL9         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL15        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
|             |       |       |       |       |       |       |       |       |     |            |
| BL16        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL17        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL19        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL21        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL22        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 1   | 1          |
| BL23        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL24        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL25        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL27        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 1   | 1          |
| BL29        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL30        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL31        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| No. of 1's  | 8     | 8     | 8     | 8     | 8     | 8     | 16    | 16    | 8   |            |

**Note:**

DBI enabled burst

Table 7-7 Data Pattern for IDD4R (DBI On)

| DBI ON Case |       |       |       |       |       |       |       |       |     | No. of 1's |
|-------------|-------|-------|-------|-------|-------|-------|-------|-------|-----|------------|
|             | DQ[7] | DQ[6] | DQ[5] | DQ[4] | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI |            |
| BL0         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 1   | 1          |
| BL1         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5         | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6         | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL7         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8         | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 1          |
| BL9         | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL15        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL16        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 1          |
| BL17        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 0          |
| BL19        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL21        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL22        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL23        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL24        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL25        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26        | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0   | 1          |
| BL27        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 0   | 2          |
| BL29        | 1     | 1     | 1     | 1     | 0     | 0     | 0     | 0     | 0   | 4          |
| BL30        | 0     | 0     | 0     | 0     | 0     | 0     | 1     | 1     | 1   | 3          |
| BL31        | 0     | 0     | 0     | 0     | 1     | 1     | 1     | 1     | 0   | 4          |
| No. of 1's  | 8     | 8     | 8     | 8     | 8     | 8     | 16    | 16    | 8   |            |

## 7.2 IDD Specifications

IDD values are for the entire operating voltage range, and all of them are for the entire standard range.

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Table 7-8 IDD Specification Parameters and Operating Conditions

| Parameter/Condition                                                                                                                                                                                          | Symbol  | Power Supply | Note |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|--------------|------|
| Operating one bank active-precharge current:<br>tCK = tCKmin; tRC = tRCmin; CKE is HIGH; CS is LOW between valid commands; CA bus inputs are switching; Data bus inputs are stable, ODT disabled             | IDD01   | VDD1         |      |
|                                                                                                                                                                                                              | IDD02   | VDD2         |      |
|                                                                                                                                                                                                              | IDD0Q   | VDDQ         | 3    |
| Idle power-down standby current: tCK = tCKmin; CKE is LOW; CS is LOW; All banks are idle; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                              | IDD2P1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD2P2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD2PQ  | VDDQ         | 3    |
| Idle power-down standby current with clock stop: CK_t = LOW, CK_c = HIGH; CKE is LOW; CS is LOW; All banks are idle; CA bus inputs are stable; Data bus inputs are stable; ODT disabled                      | IDD2PS1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD2PS2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD2PSQ | VDDQ         | 3    |
| Idle non power-down standby current: tCK = tCKmin; CKE is HIGH; CS is LOW; All banks are idle; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                         | IDD2N1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD2N2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD2NQ  | VDDQ         | 3    |
| Idle non power-down standby current with clock stopped: CK_t = LOW; CK_c = HIGH; CKE is HIGH; CS is LOW; All banks are idle; CA bus inputs are stable; Data bus inputs are stable; ODT disabled              | IDD2NS1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD2NS2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD2NSQ | VDDQ         | 3    |
| Active power-down standby current: tCK = tCKmin; CKE is LOW; CS is LOW; One bank is active; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                            | IDD3P1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD3P2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD3PQ  | VDDQ         | 3    |
| Active power-down standby current with clock stop: CK_t = LOW, CK_c = HIGH; CKE is LOW; CS is LOW; One bank is active; CA bus inputs are stable; Data bus inputs are stable; ODT disabled                    | IDD3PS1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD3PS2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD3PSQ | VDDQ         | 4    |
| Active non-power-down standby current: tCK = tCKmin; CKE is HIGH; CS is LOW; One bank is active; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                       | IDD3N1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD3N2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD3NQ  | VDDQ         | 4    |
| Active non-power-down standby current with clock stopped: CK_t = LOW, CK_c = HIGH; CKE is HIGH; CS is LOW; One bank is active; CA bus inputs are stable; Data bus inputs are stable; ODT disabled            | IDD3NS1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD3NS2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD3NSQ | VDDQ         | 4    |
| Operating burst READ current: tCK = tCKmin; CS is LOW between valid commands; One bank is active; BL = 16 or 32; RL = RL(MIN); CA bus inputs are switching; 50% data change each burst transfer ODT disabled | IDD4R1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD4R2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD4RQ  | VDDQ         | 5    |
| Operating burst WRITE current: tCK = tCKmin; CS is LOW between valid commands; One bank is active; BL = 16 or 32; WL = WLmin; CA bus inputs are switching; 50% data change each burst transfer ODT disabled  | IDD4W1  | VDD1         |      |
|                                                                                                                                                                                                              | IDD4W2  | VDD2         |      |
|                                                                                                                                                                                                              | IDD4WQ  | VDDQ         | 4    |
| All bank REFRESH Burst current: tCK = tCKmin; CKE is HIGH between valid commands; tRC = tRFCabmin; Burst refresh; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                      | IDD51   | VDD1         |      |
|                                                                                                                                                                                                              | IDD52   | VDD2         |      |
|                                                                                                                                                                                                              | IDD5Q   | VDDQ         | 4    |
| All bank REFRESH Average current: tCK = tCKmin; CKE is HIGH between valid commands; tRC = tREFI; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                       | IDD5AB1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD5AB2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD5ABQ | VDDQ         | 4    |
| Per bank REFRESH Average current: tCK = tCKmin; CKE is HIGH between valid commands; tRC = tREFI/8; CA bus inputs are switching; Data bus inputs are stable; ODT disabled                                     | IDD5PB1 | VDD1         |      |
|                                                                                                                                                                                                              | IDD5PB2 | VDD2         |      |
|                                                                                                                                                                                                              | IDD5PBQ | VDDQ         | 4    |

| Parameter/Condition                                                                                                                                                             | Symbol | Power Supply | Note       |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------|--------------|------------|
| Power Down Self Refresh current (-25 °C to +85 °C):CK_t=LOW, CK_c=HIGH;CKE is LOW;CA bus inputs are stable;Data bus inputs are stable;Maximum 1x Self Refresh Rate;ODT disabled | IDD61  | VDD1         | 6,7,8,10   |
|                                                                                                                                                                                 | IDD62  | VDD2         | 6,7,8,10   |
|                                                                                                                                                                                 | IDD6Q  | VDDQ         | 4,6,7,8,10 |

**Note:**

- 1 DBI Published IDD values are the maximum of the distribution of the arithmetic mean.
- 2 ODT disabled: MR11[2:0] = 000B.
- 3 IDD current specifications are tested after the device is properly initialized.
- 4 Measured currents are the summation of VDDQ and VDD2.
- 5 Guaranteed by design with output load = 5pF and RON = 40 Ω.
- 6 This is the general definition that applies to full array Self Refresh.
- 7 Supplier datasheets may contain additional Self Refresh IDD values for temperature subranges within the Standard or elevated Temperature Ranges.
- 8 For all IDD measurements, VIHCKE = 0.8 x VDD2, VILCKE = 0.2 x VDD2.
- 9 IDD6 85 °C is guaranteed, IDD6 45 °C is typical of the distribution of the arithmetic mean.
- 10 Dual Channel devices are specified in dual channel operation (both channels operating together).

## 7.3 LPDDR4X IDD Parameters - Single Die

VDD2 = 1.06 ~ 1.17V, VDDQ = 0.57 ~ 0.65V; VDD1 = 1.70 ~ 1.95V; T<sub>C</sub> = -25°C ~ +85°C

| Symbol              | Supply | 4266 Mbps | Unit |
|---------------------|--------|-----------|------|
| IDD0 <sub>1</sub>   | VDD1   | 2.84      | mA   |
| IDD0 <sub>2</sub>   | VDD2   | 29.40     |      |
| IDD2P <sub>1</sub>  | VDD1   | 0.49      | mA   |
| IDD2P <sub>2</sub>  | VDD2   | 1.80      |      |
| IDD2PS <sub>1</sub> | VDD1   | 0.49      | mA   |
| IDD2PS <sub>2</sub> | VDD2   | 1.80      |      |
| IDD2N <sub>1</sub>  | VDD1   | 0.52      | mA   |
| IDD2N <sub>2</sub>  | VDD2   | 12.12     |      |
| IDD2NS <sub>1</sub> | VDD1   | 0.52      | mA   |
| IDD2NS <sub>2</sub> | VDD2   | 9.24      |      |
| IDD3P <sub>1</sub>  | VDD1   | 0.49      | mA   |
| IDD3P <sub>2</sub>  | VDD2   | 3.07      |      |
| IDD3PS <sub>1</sub> | VDD1   | 0.49      | mA   |
| IDD3PS <sub>2</sub> | VDD2   | 3.07      |      |
| IDD3N <sub>1</sub>  | VDD1   | 1.12      | mA   |
| IDD3N <sub>2</sub>  | VDD2   | 20.04     |      |
| IDD3NS <sub>1</sub> | VDD1   | 1.12      | mA   |
| IDD3NS <sub>2</sub> | VDD2   | 17.16     |      |
| IDD4R <sub>1</sub>  | VDD1   | 3.76      | mA   |
| IDD4R <sub>2</sub>  | VDD2   | 236.52    |      |
| IDD4RQ              | VDDQ   | 102.48    |      |
| IDD4W <sub>1</sub>  | VDD1   | 3.71      | mA   |
| IDD4W <sub>2</sub>  | VDD2   | 188.28    |      |

| Symbol              | Supply | 4266 Mbps | Unit |
|---------------------|--------|-----------|------|
| IDD5 <sub>1</sub>   | VDD1   | 18.95     | mA   |
| IDD5 <sub>2</sub>   | VDD2   | 130.44    |      |
| IDD5AB <sub>1</sub> | VDD1   | 2.39      | mA   |
| IDD5AB <sub>2</sub> | VDD2   | 23.88     |      |
| IDD5PB <sub>1</sub> | VDD1   | 2.39      | mA   |
| IDD5PB <sub>2</sub> | VDD2   | 24.36     |      |

## 7.4 LPDDR4X IDD6 Parameters - Single Die

VDD2 = 1.06 ~ 1.17V, VDDQ = 0.57 ~ 0.65V; VDD1 = 1.70 ~ 1.95V; T<sub>C</sub> = -25°C ~ +85°C

| Temperature | Symbol            | Supply | Full-Array Self Refresh Current | Unit |
|-------------|-------------------|--------|---------------------------------|------|
| 25°C        | IDD6 <sub>1</sub> | VDD1   | 0.50                            | mA   |
|             | IDD6 <sub>2</sub> | VDD2   | 1.49                            |      |
| 85°C        | IDD6 <sub>1</sub> | VDD1   | 1.85                            | mA   |
|             | IDD6 <sub>2</sub> | VDD2   | 9.45                            |      |

## 8. Electrical Characteristics and AC Timing

### 8.1 Clock Specification

The jitter specified is a random jitter meeting a Gaussian distribution. Input clocks violating the min/max values may result in malfunction of the LPDDR4X device.

#### 8.1.1 Definition for tCK(avg) and nCK

tCK(avg) is calculated as the average clock period across any consecutive 200 cycle window, where each clock period is calculated from rising edge to rising edge.

$$tCK(avg) = \left( \sum_{j=1}^N tCK_j \right) / N \quad N=200$$

Unit 'tCK(avg)' represents the actual clock average tCK(avg) of the input clock under operation. Unit 'nCK' represents one clock cycle of the input clock, counting the actual clock edges. tCK(avg) may change by up to +/-1% within a 100 clock cycle window, provided that all jitter and timing specs are met.

#### 8.1.2 Definition for tCK(abs)

tCK(abs) is defined as the absolute clock period, as measured from one rising edge to the next consecutive rising edge.

tCK(abs) is not subject to production test.

##### 8.1.2.1 Definition for tCH(avg) and tCL(avg)

tCH(avg) is defined as the average high pulse width, as calculated across any consecutive 200 high pulses.

$$t_{CH(avg)} = \left| \sum_{j=1}^N t_{CHj} \right| / \{N \times t_{CK(avg)}\} \quad N=200$$

$t_{CL(avg)}$  is defined as the average low pulse width, as calculated across any consecutive 200 low pulses.

$$t_{CL(avg)} = \left| \sum_{j=1}^N t_{CLj} \right| / \{N \times t_{CK(avg)}\} \quad N=200$$

### 8.1.2.2 Definition for $t_{CH(abs)}$ and $t_{CL(abs)}$

$t_{CH(abs)}$  is the absolute instantaneous clock high pulse width, as measured from one rising edge to the following falling edge.

$t_{CL(abs)}$  is the absolute instantaneous clock low pulse width, as measured from one falling edge to the following rising edge.

Both  $t_{CH(abs)}$  and  $t_{CL(abs)}$  are not subject to production test.

### 8.1.2.3 Definition for $t_{JIT(per)}$

$t_{JIT(per)}$  is the single period jitter defined as the largest deviation of any signal  $t_{CK}$  from  $t_{CK(avg)}$ .

$t_{JIT(per)} = \text{Min/max of } \{t_{CKi} - t_{CK(avg)} \text{ where } i = 1 \text{ to } 200\}.$

$t_{JIT(per),act}$  is the actual clock jitter for a given system.

$t_{JIT(per),allowed}$  is the specified allowed clock period jitter.

$t_{JIT(per)}$  is not subject to production test.

### 8.1.2.4 Definition for tJIT(cc)

tJIT(cc) is defined as the absolute difference in clock period between two consecutive clock cycles.

$tJIT(cc) = \text{Max of } \{tCK(i+1) - tCK(i)\}$ .

tJIT(cc) defines the cycle to cycle jitter.

tJIT(cc) is not subject to production test.

## 8.2 Clock Timing

Table 8-1 Clock AC Timings

| Parameter                                       | Symbol    | 1600/2400/3200            |     |       |     | Unit     |     |       |     |      |
|-------------------------------------------------|-----------|---------------------------|-----|-------|-----|----------|-----|-------|-----|------|
|                                                 |           | Min                       |     | Max   |     |          |     |       |     |      |
| Clock Timing                                    |           |                           |     |       |     |          |     |       |     |      |
| Average High pulse width                        | tCH(avg)  | 0.46                      |     | 0.54  |     | tCK(avg) |     |       |     |      |
| Average Low pulse width                         | tCL(avg)  | 0.46                      |     | 0.54  |     | tCK(avg) |     |       |     |      |
| Absolute clock period                           | tCK(abs)  | tCK(avg)MIN +tJIT(per)MIN |     |       | -   | ns       |     |       |     |      |
| Absolute High clock pulse width                 | tCH(abs)  | 0.43                      |     | 0.57  |     | tCK(avg) |     |       |     |      |
| Absolute Low clock pulse width                  | tCL(abs)  | 0.43                      |     | 0.57  |     | tCK(avg) |     |       |     |      |
| Parameter                                       | Symbol    | 1600                      |     | 2400  |     | 3200     |     | 4266  |     | Unit |
|                                                 |           | Min                       | Max | Min   | Max | Min      | Max | Min   | Max |      |
| Clock Timing                                    |           |                           |     |       |     |          |     |       |     |      |
| Average clock period                            | tCK(avg)  | 1.25                      | 100 | 0.833 | 100 | 0.625    | 100 | 0.468 | 100 | ns   |
| Clock period jitter                             | tJIT(per) | -70                       | 70  | -50   | 50  | -40      | 40  | -     | TBD | ps   |
| Maximum Clock Jitter between consecutive cycles | tJIT(cc)  | -                         | 140 | -     | 100 | -        | 80  | -     | TBD | ps   |

## 8.3 Temperature Derating for AC Timing

Table 8-2 Temperature Derating AC Timing

| Parameter                                       | Symbol | Min/Max | Data Rate                                  | Unit |
|-------------------------------------------------|--------|---------|--------------------------------------------|------|
|                                                 |        |         | 533/1066/1600/2133/<br>2667/3200/3733/4267 |      |
| Temperature Derating <sup>1</sup>               |        |         |                                            |      |
| DQS output access time from CK_t/CK_c (derated) | tDQSCK | Min     | 3600                                       | ps   |
| RAS-to-CAS delay (derated)                      | tRCD   | Min     | tRCD + 1.875                               | ns   |

| Parameter                                      | Symbol | Min/Max | Data Rate                                  | Unit |
|------------------------------------------------|--------|---------|--------------------------------------------|------|
|                                                |        |         | 533/1066/1600/2133/<br>2667/3200/3733/4267 |      |
| ACTIVATE-to- ACTIVATE command period (derated) | tRC    | Min     | tRC + 3.75                                 | ns   |
| Row active time (derated)                      | tRAS   | Min     | tRAS + 1.875                               | ns   |
| Row precharge time (derated)                   | tRP    | Min     | tRP + 1.875                                | ns   |
| Active bank A to active bank B (derated)       | tRRD   | Min     | tRRD + 1.875                               | ns   |

**Note:**

Timing derating applies for operation at 85 °C to 105 °C.

## 8.4 CA Rx Voltage and Timing

The command and address(CA) including CS input receiver compliance mask for voltage and timing is shown in Figure 8-1. All CA, CS signals apply the same compliance mask and operate in single data rate mode.

The CA input receiver mask for voltage and timing is shown in Figure 8-2. The receiver mask (Rx Mask) defines the area that the input signal must not encroach in order for the DRAM input receiver to be expected to be able to successfully capture a valid input signal; it is not the valid data-eye.

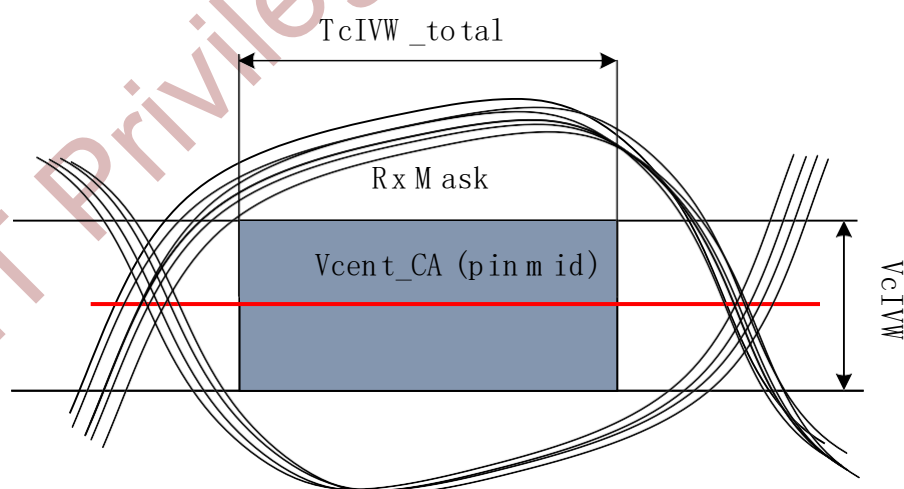


Figure 8-1 CA Receiver(Rx) Mask

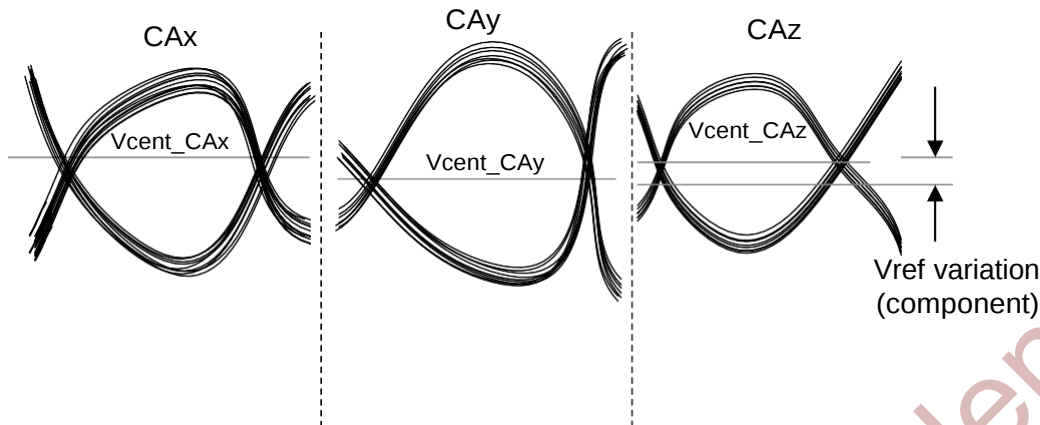
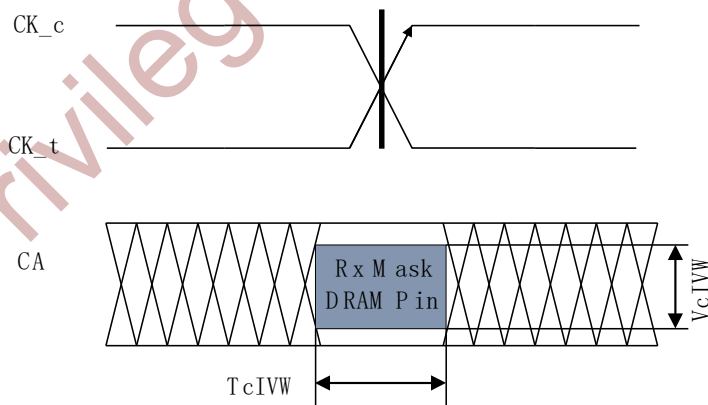


Figure 8-2 Across Pin  $V_{REFCA}$  Voltage Variation

$V_{cent\_CA}(\text{pin mid})$  is defined as the midpoint between the largest  $V_{cent\_CA}$  voltage level and the smallest  $V_{cent\_CA}$  voltage level across all CA and CS pins for a given DRAM component. Each CA  $V_{cent}$  level is defined by the center, i.e., widest opening, of the cumulative data input eye as depicted in Figure 8-2. This clarifies that any DRAM component level variation must be accounted for within the DRAM CA Rx mask. The component level  $V_{REF}$  will be set by the system to account for  $R_{on}$  and ODT settings.

CK\_t, CK\_c Data-in at DRAM Ball Minimum CA Eye center aligned



$T_{cIVW}$  for all CA signals is defined as centered on the CK\_t/CK\_c crossing at DRAM pin

Figure 8-3 CA Timings at the DRAM Pins

All of the timing terms in Figure 8-3 are measured from the CK\_t/CK\_c to the center(midpoint) of the  $T_{cIVW}$  window taken at the  $V_{cIVW\_total}$  voltage levels centered around  $V_{cent\_CA}(\text{pin mid})$ .

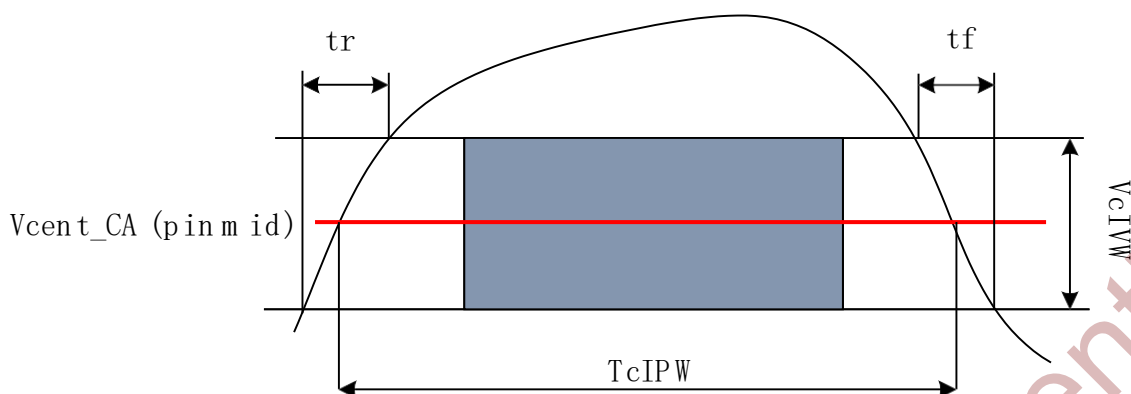


Figure 8-4 CA TcIPW and SRIN\_cIVW definition (for each input pulse)

**Note:**

SRIN\_cIVW=VcIVW\_Total/(tr or tf), signal must be monotonic within tr and tf range.

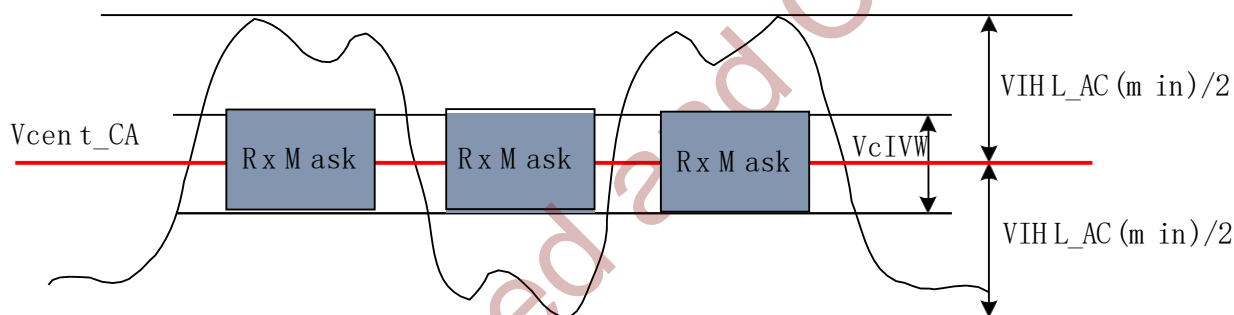


Figure 8-5 CA VIH\_L\_AC Definition (for Each Input Pulse)

Table 8-3 DRAM CMD/ADR, CS

\* UI=tck(avg)min

| Symbol    | Parameter                         | DQ-1333 <sup>a</sup> /1600/1867 |     | DQ-3200 |     | DQ-4266 |     | Unit | Note  |
|-----------|-----------------------------------|---------------------------------|-----|---------|-----|---------|-----|------|-------|
|           |                                   | Min                             | Max | Min     | Max | Min     | Max |      |       |
| VcIVW     | Rx Mask voltage - p-p             | -                               | 175 | -       | 155 | -       | 145 | mV   | 1,2,3 |
| TcIVW     | Rx timing window                  | -                               | 0.3 | -       | 0.3 | -       | 0.3 | UI   |       |
| VIHL_AC   | CA AC input pulse amplitude pk-pk | 210                             | -   | 190     | -   | 180     | -   | mV   | 4,7   |
| TcIPW     | CA input pulse width              | 0.55                            |     | 0.6     |     | 0.6     |     | UI   | 5     |
| SRIN_cIVW | Input Slew Rate over VcIVW        | 1                               | 7   | 1       | 7   | 1       | 7   | V/ns | 6     |

a. The following Rx voltage and absolute timing requirements apply for DQ operating frequencies at or below 1333 for all speed bins. For example the TcIVW(ps) = 450ps at or below 1333 operating frequencies.

**Note:**

- 1 CA Rx mask voltage and timing parameters at the pin including voltage and temperature drift.
- 2 Rx mask voltage  $V_{cIVW}$  total(max) must be centered around  $V_{cent\_CA}$ (pin mid).
- 3  $V_{cent\_CA}$  must be within the adjustment range of the CA internal  $V_{ref}$ .
- 4 CA only input pulse signal amplitude into the receiver must meet or exceed  $VIHL\_AC$  at any point over the total UI. No timing requirement above level.  $VIHL\_AC$  is the peak to peak voltage centered around  $V_{cent\_CA}$ (pin mid) such that  $VIHL\_AC/2$  min must be met both above and below  $V_{cent\_CA}$ .
- 5 CA only minimum input pulse width defined at the  $V_{cent\_CA}$ (pin mid).
- 6 Input slew rate over  $V_{cIVW}$  Mask centered at  $V_{cent\_CA}$ (pin mid).
- 7  $VIHL\_AC$  does not have to be met when no transitions are occurring.

## 8.5 DRAM Data Timing

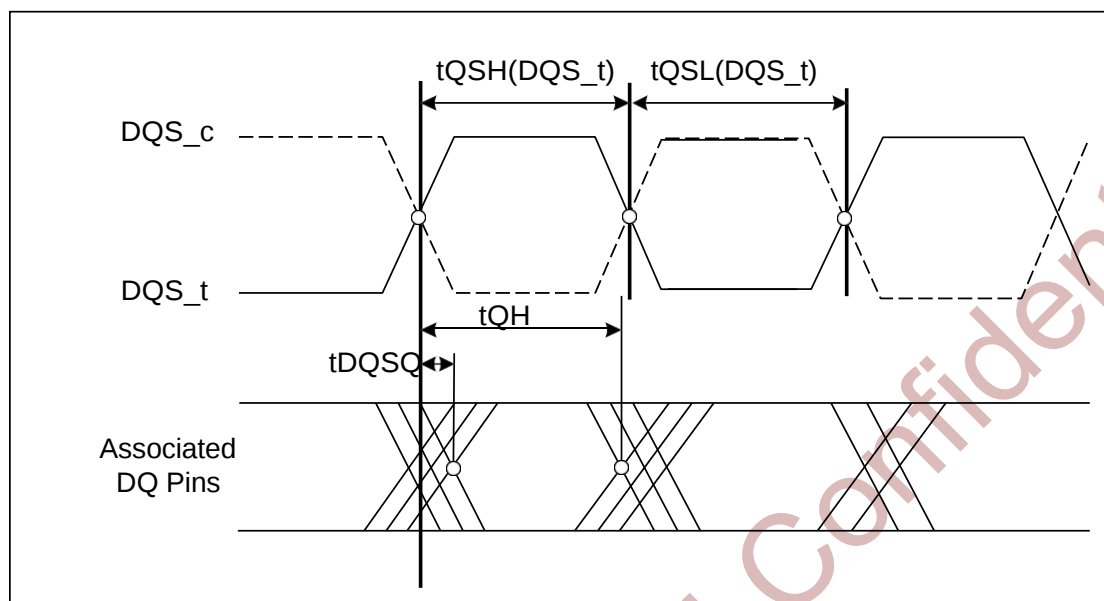


Figure 8-6 Read Data Timing Definitions  $t_{QH}$  and  $t_{DQSQ}$  across all DQ Signals per DQS Group

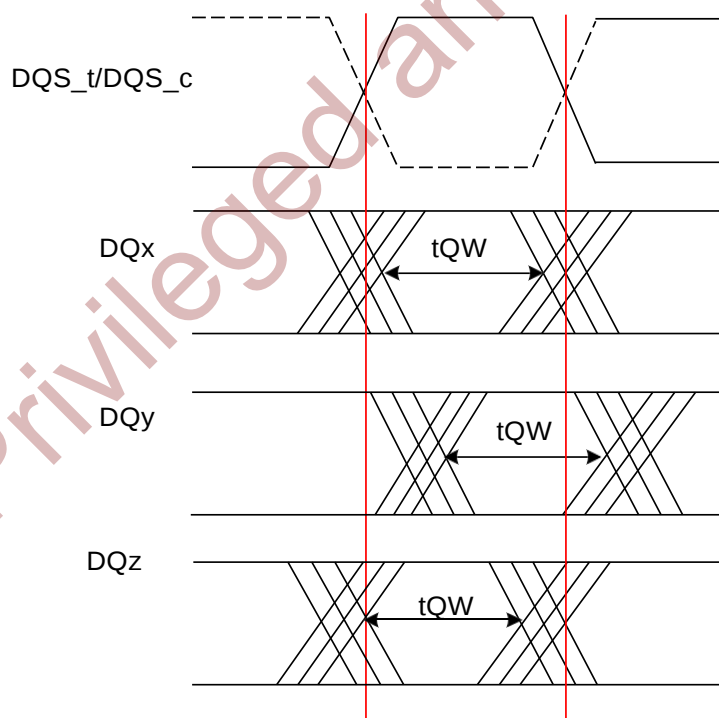


Figure 8-7 Read Data Timing  $t_{QW}$  Valid Window Defined per DQ Signal

Table 8-4 Read Output Timings

Unit UI = tCK(avg)min/2

| Symbol                                                                                                                                                                                                         | Parameter                                                         | DQ-1600/1867            |      | DQ-2133/2400            |      | DQ-3200                 |      | DQ-4266                 |      | Unit     | Note |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------|-------------------------|------|-------------------------|------|-------------------------|------|-------------------------|------|----------|------|
|                                                                                                                                                                                                                |                                                                   | Min                     | Max  | Min                     | Max  | Min                     | Max  | Min                     | Max  |          |      |
| Data Timing                                                                                                                                                                                                    |                                                                   |                         |      |                         |      |                         |      |                         |      |          |      |
| tDQSQ                                                                                                                                                                                                          | DQS_t,DQS_c to DQ Skew total, per group, per access (DBIDisabled) | -                       | 0.18 | -                       | 0.18 | -                       | 0.18 | -                       | 0.18 | UI       |      |
| tQH                                                                                                                                                                                                            | DQ output hold time total from DQS_t, DQS_c (DBI-Disabled)        | min(tQSH, tQSL)         | -    | min(tQSH, tQSL)         | -    | min(tQSH, tQSL)         | -    | min(tQSH, tQSL)         | -    | UI       |      |
| tQW_total                                                                                                                                                                                                      | DQ output window time total, per pin (DBI-Disabled)               | 0.75                    | -    | 0.73                    | -    | 0.7                     | -    | 0.7                     | -    | UI       | 3    |
| tQW_dj                                                                                                                                                                                                         | DQ output window time deterministic, per pin (DBI-Disabled)       | TBD                     | -    | TBD                     | -    | TBD                     | -    | TBD                     | -    | UI       | 2,3  |
| tDQSQ_DBI                                                                                                                                                                                                      | DQS_t,DQS_c to DQ Skew total,per group, per access (DBI-Enabled)  | -                       | 0.18 | -                       | 0.18 | -                       | 0.18 | -                       | 0.18 | UI       | 6    |
| tQH_DBI                                                                                                                                                                                                        | DQ output hold time total from DQS_t, DQS_c (DBI-Enabled)         | Min (tQSH_DBI,tQSL_DBI) | -    | Min (tQSH_DBI,tQSL_DBI) | -    | Min (tQSH_DBI,tQSL_DBI) | -    | Min (tQSH_DBI,tQSL_DBI) | TBD  | UI       |      |
| tQW_total_DBI                                                                                                                                                                                                  | DQ output window time total, per pin (DBI-Enabled)                | 0.75                    | -    | 0.73                    | -    | 0.7                     | -    | 0.7                     | -    | UI       | 3    |
| Data Strobe Timing                                                                                                                                                                                             |                                                                   |                         |      |                         |      |                         |      |                         |      |          |      |
| tQSL                                                                                                                                                                                                           | DQS, DQS# differential output low time (DBI-Disabled)             | tCL(abs) -0.05          | -    | tCL(abs) -0.05          | -    | tCL(abs) -0.05          | -    | tCL(abs) -0.05          | -    | tCK(avg) | 3,4  |
| tQSH                                                                                                                                                                                                           | DQS, DQS# differential output high time (DBI-Disabled)            | tCH(abs) -0.05          | -    | tCH(abs) -0.05          | -    | tCH(abs) -0.05          | -    | tCH(abs) -0.05          | -    | tCK(avg) | 3,5  |
| tQSL_DBI                                                                                                                                                                                                       | DQS, DQS# differential output low time (DBI-Enabled)              | tCL(abs) -0.045         | -    | tCL(abs) -0.045         | -    | tCL(abs) -0.045         | -    | tCL(abs) -0.045         | -    | tCK(avg) | 4,6  |
| tQSH_DBI                                                                                                                                                                                                       | DQS, DQS# differential output high time (DBI-Enabled)             | tCH(abs) -0.045         | -    | tCH(abs) -0.045         | -    | tCH(abs) -0.045         | -    | tCH(abs) -0.045         | -    | tCK(avg) | 5,6  |
| a. The following Rx voltage and absolute timing requirements apply for DQ operating frequencies at or below 1333 for all speed bins. For example the TcIVW(ps) = 450ps at or below 1333 operating frequencies. |                                                                   |                         |      |                         |      |                         |      |                         |      |          |      |

**Note:**

- 1 The deterministic component of the total timing. Measurement method tbd.
- 2 This parameter will be characterized and guaranteed by design.
- 3 This parameter is function of input clock jitter. These values assume the min  $t_{CH(ABS)}$  and  $t_{CL(ABS)}$ . When the input clock jitter min  $t_{CH(ABS)}$  and  $t_{CL(ABS)}$  is 0.44 or greater of  $t_{CK(AVG)}$  the min value of  $t_{QSL}$  will be  $t_{CL(ABS)} - 0.04$  and  $t_{QSH}$  will be  $t_{CH(ABS)} - 0.04$ .
- 4  $t_{QSL}$  describes the instantaneous differential output low pulse width on  $DQS_t - DQS_c$ , as it measured the next rising edge from an arbitrary falling edge.
- 5  $t_{QSH}$  describes the instantaneous differential output high pulse width on  $DQS_t - DQS_c$ , as it measured the next rising edge from an arbitrary falling edge.
- 6 This parameter is function of input clock jitter. These values assume the min  $t_{CH(ABS)}$  and  $t_{CL(ABS)}$ . When the input clock jitter min  $t_{CH(ABS)}$  and  $t_{CL(ABS)}$  is 0.44 or greater of  $t_{CK(AVG)}$  the min value of  $t_{QSL}$  will be  $t_{CL(ABS)} - 0.04$  and  $t_{QSH}$  will be  $t_{CH(ABS)} - 0.04$ .

## 8.6 DQ Rx Voltage and Timing

The DQ input receiver mask for voltage and timing is shown [Figure 8-8](#) is applied per pin. The “total” mask ( $V_{dIVW\_total}$ ,  $T_{dIVW\_total}$ ) defines the area the input signal must not encroach in order for the DQ input receiver to successfully capture an input signal with a BER of lower than tbd. The mask is a receiver property and it is not the valid data-eye.

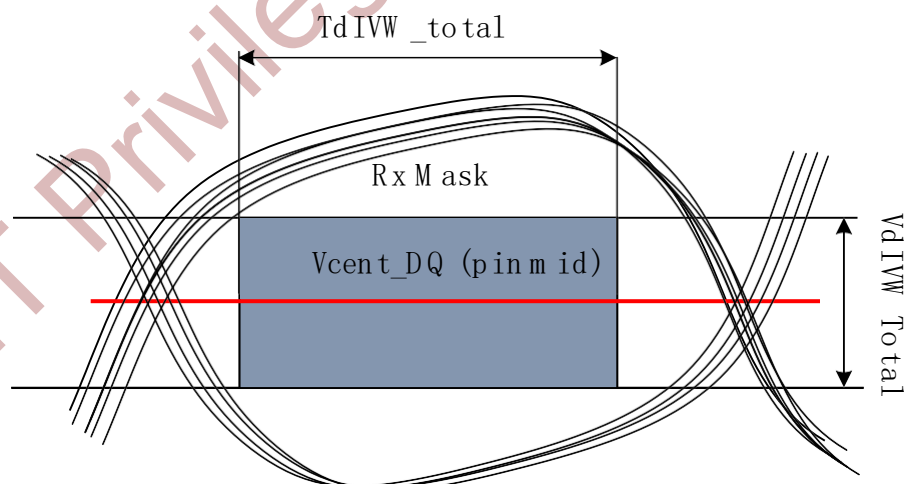


Figure 8-8 DQ Receiver(Rx) Mask

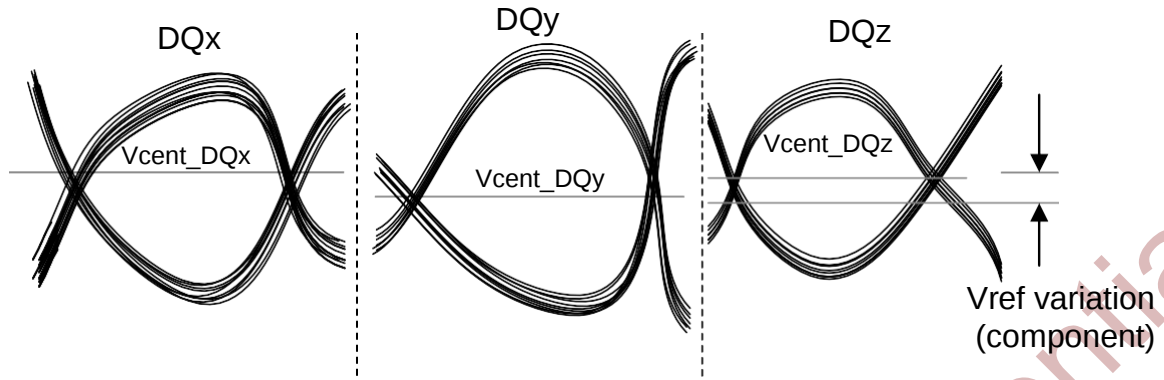


Figure 8-9 Across Pin Vref DQ Voltage Variation

Vcent\_DQ(pin\_mid) is defined as the midpoint between the largest Vcent\_DQ voltage level and the smallest Vcent\_DQ voltage level across all DQ pins for a given DRAM component. Each DQ Vcent is defined by the center, i.e., widest opening, of the cumulative data input eye as depicted in Figure 8-9. This clarifies that any DRAM component level variation must be accounted for within the DRAM Rx mask. The component level Vref will be set by the system to account for Ron and ODT settings.

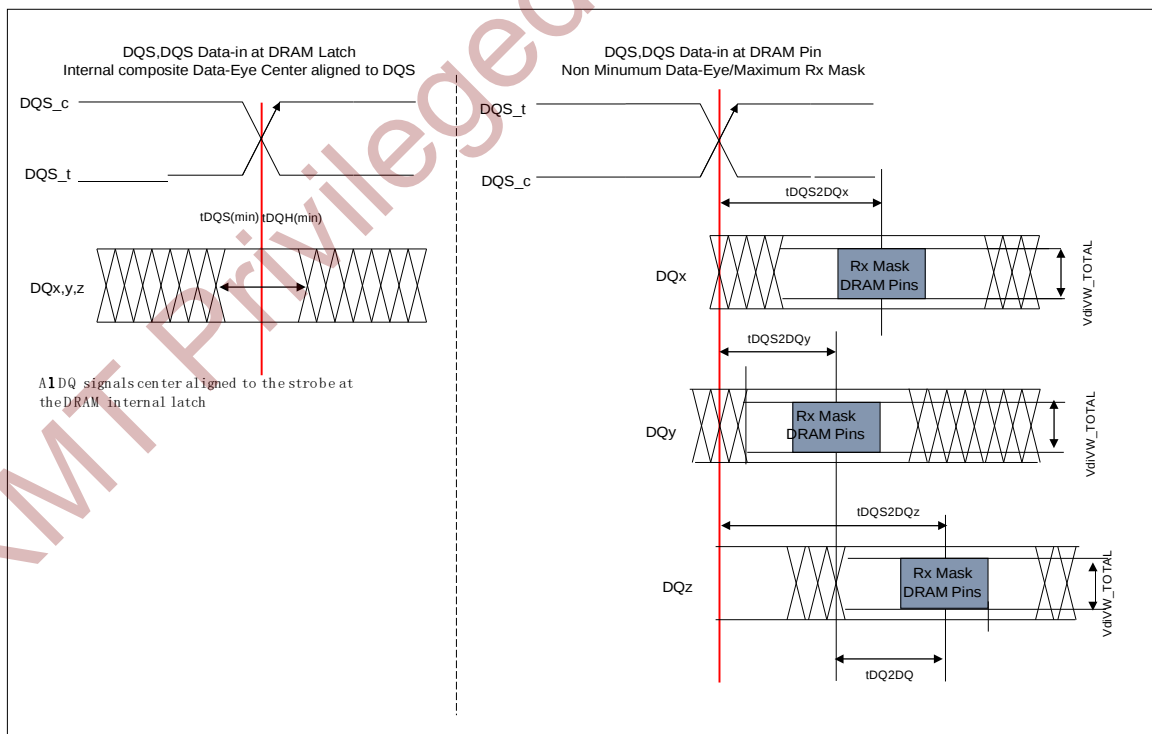


Figure 8-30 DQ to DQS tDQS2DQ and tDQ2DQ Timings at the DRAM Pins Referenced from the Internal Latch

**Note:**

- 1 The tDQS2DQ is measured at the center(midpoint) of the TdiVW window.
- 2 The DQz represents the max tDQS2DQ in this example
- 3 DQy represents the min tDQS2DQ in this example

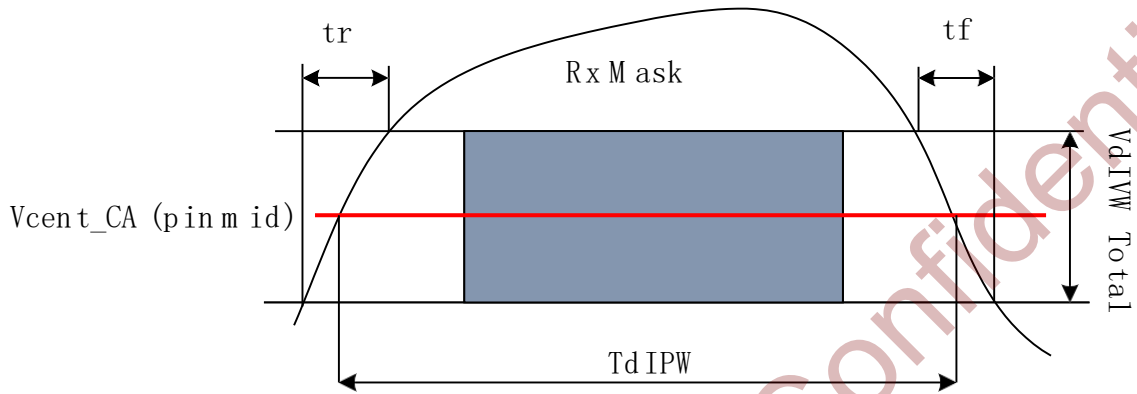


Figure 8-10 DQ TdIPW and SRIN\_dIVW Definition (for Each Input Pulse)

**Note:**

$SRIN\_dIVW = VdIVW\_Total / (tr \text{ or } tf)$ , signal must be monotonic within tr and tf range.

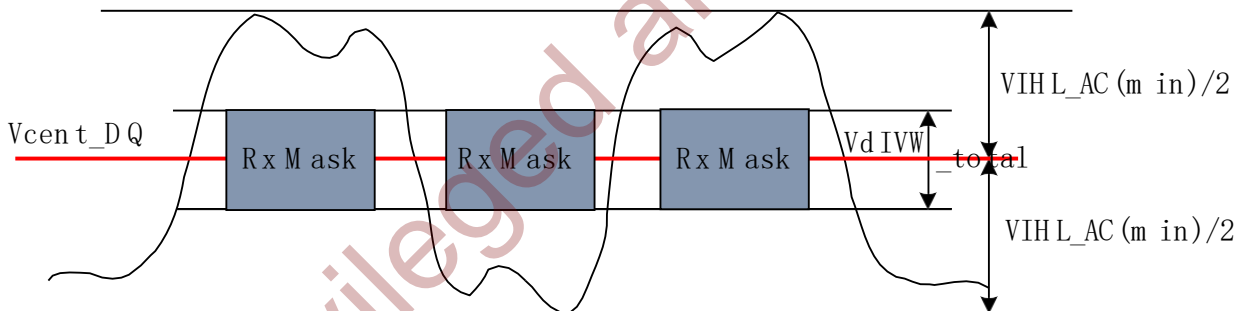


Figure 8-11 DQ VIH\_L\_AC definition (for Each Input Pulse)

Table 8-5 DRAM DQs in Receive Mode

\* UI=tCK(avg)min/2

| Symbol            | Parameter                                               | DQ-1600/1867 <sup>a</sup> /2133/2400 |      | DQ-3200 |      | DQ-4266 |      | Unit     | Note     |
|-------------------|---------------------------------------------------------|--------------------------------------|------|---------|------|---------|------|----------|----------|
|                   |                                                         | Min                                  | Max  | Min     | Max  | Min     | Max  |          |          |
| VdIVW_total       | Rx Mask voltage - p-p total                             | -                                    | 140  | -       | 140  | -       | 120  | mV       | 1,2,3,4  |
| TdIVW_total       | Rx timing window total (At VdIVW voltage levels)        | -                                    | 0.22 | -       | 0.25 | -       | 0.25 | UI       | 1,2,4    |
| TdIVW_1bit        | Rx timing window 1 bit toggle (At VdIVW voltage levels) | -                                    | TBD  | -       | TBD  | -       | TBD  | UI       | 1,2,4,12 |
| VIHL_AC           | DQ AC input pulse amplitude pk-pk                       | 180                                  | -    | 180     | -    | 170     | -    | UI       | 5,13     |
| TdIPW DQ          | Input pulse width (At Vcent_DQ)                         | 0.45                                 |      | 0.45    |      | 0.45    | -    | UI       | 6        |
| tDQS2DQ           | DQ to DQS offset                                        | 200                                  | 800  | 200     | 800  | 200     | 800  | ps       | 7        |
| tDQ2DQ            | DQ to DQ offset                                         | -                                    | 30   | -       | 30   | -       | 30   | ps       | 8        |
| tQSL              | tDQS2DQ_temp DQ to DQS offset temperature variation     | -                                    | 0.6  | -       | 0.6  | -       | 0.6  | ps/°C    | 9        |
| tDQS2DQ_volt      | DQ to DQS offset voltage variation                      | -                                    | 33   | -       | 33   | -       | 33   | ps/50 mV | 10       |
| SRIN_dIVW         | Input Slew Rate over VdIVW_total                        | 1                                    | 7    | 1       | 7    | 1       | 7    | V/ns     | 11       |
| tDQS2DQ_rank2rank | DQ to DQS offset rank to rank variation                 | -                                    | 200  | -       | 200  | -       | 200  | ps       | 14,15,16 |

a. The Rx voltage and absolute timing requirements apply for all DQ operating frequencies at or below 1600 for all speed bins. For example TdIVW\_total(ps) = 137.5ps at or below 1600 operating frequencies

**Note:**

- 1 The Data Rx mask voltage and timing parameters are applied per pin and includes the DRAM DQ to DQS voltage AC noise impact for frequencies >20 MHz and max voltage of 45mv pk-pk from DC-20MHz at a fixed temperature on the package. The voltage supply noise must comply to the component Min-Max DC operating conditions.
- 2 The design specification is a BER <TBD. The BER will be characterized and extrapolated if necessary using a dual dirac method.
- 3 Rx mask voltage VdIVW total(max) must be centered around Vcent\_DQ(pin\_mid).
- 4 Vcent\_DQ must be within the adjustment range of the DQ internal Vref.
- 5 DQ only input pulse amplitude into the receiver must meet or exceed VIH AC at any point over the total UI. No timing requirement above level. VIH AC is the peak to peak voltage centered around Vcent\_DQ(pin\_mid) such that VIH AC/2 min must be met both above and below Vcent\_DQ.
- 6 DQ only minimum input pulse width defined at the Vcent\_DQ(pin\_mid).
- 7 DQ to DQS offset is within byte from DRAM pin to DRAM internal latch. Includes all DRAM process, voltage and temperature variation.
- 8 DQ to DQ offset defined within byte from DRAM pin to DRAM internal latch for a given component.
- 9 TDQS2DQ max delay variation as a function of temperature.
- 10 TDQS2DQ max delay variation as a function of the DC voltage variation for VDDQ and VDD2. It includes the VDDQ and VDD2 AC noise impact for frequencies > 20MHz and max voltage of 45mv pk-pk from DC-20MHz at a fixed temperature on the package. For tester measurement VDDQ = VDD2 is assumed.
- 11 Input slew rate over VdIVW Mask centered at Vcent\_DQ(pin\_mid).
- 12 Rx mask defined for a one pin toggling with other DQ signals in a steady state.
- 13 VIH AC does not have to be met when no transitions are occurring.
- 14 The same voltage and temperature are applied to tDQS2DQ\_rank2rank.
- 15 tDQS2DQ\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.
- 16 tDQS2DQ\_rank2rank support was added to JESD209-4B, some older devices designed to support JESD209-4 and JESD209-4A may not support this parameter. Refer to vendor datasheet.

## 9. AC Timing Parameters

- Core AC Timing [on Page 74](#)
- Read AC Timing [on Page 75](#)
- tDQSCK Timing [on Page 76](#)
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- Self Refresh AC Timing [on Page 77](#)
- Mode Register Read/Write AC Timing [on Page 78](#)
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- Command Bus Training AC Timing [on Page 79](#)
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- Write Leveling Timing [on Page 84](#)
- MPC [Write FIFO] AC Timing [on Page 84](#)
- DQS Interval Oscillator AC Timing [on Page 85](#)
- Read Preamble Training Timing [on Page 85](#)
- ZQ Calibration Timing [on Page 85](#)
- ODT CA AC Timing [on Page 85](#)
- Power-Down AC Timing [on Page 86](#)

## 9.1 Core AC Timing

Table 9-1 Core AC Timing Table (x16 mode)

| Parameter                                       | Symbol | Min/Max | Data Rate                                                                               | Unit                       |
|-------------------------------------------------|--------|---------|-----------------------------------------------------------------------------------------|----------------------------|
| <b>Core Parameters</b>                          |        |         | <b>533/1066/1600/2133/2667/3200/3733/ 4267</b>                                          |                            |
| ACTIVATE-to-ACTIVATE command period (same bank) | tRC    | MIN     | tRAS + tRPab<br>(with all bank precharge)<br>tRAS + tRPpb<br>(with per bank precharge)  | ns                         |
| Minimum Self Refresh Time (Entry to Exit)       | tSR    | MIN     | max(15ns, 3nCK)                                                                         | ns                         |
| Self Refresh exit to next valid command delay   | tXSR   | MIN     | max(tRFCab + 7.5ns, 2nCK)                                                               | ns                         |
| Exit Power-Down to next valid command delay     | tXP    | MIN     | max(7.5ns, 5nCK)                                                                        | ns                         |
| CAS-to-CAS delay                                | tCCD   | MIN     | 8                                                                                       | tCK(avg)                   |
| Internal READ to PRECHARGE command delay        | tRTP   | MIN     | max(7.5ns, 8nCK)                                                                        | ns                         |
| RAS-to-CAS delay                                | tRCD   | MIN     | max(18ns, 4nCK)                                                                         | ns                         |
| Row precharge time (single bank)                | tRPpb  | MIN     | max(18ns, 4nCK)                                                                         | ns                         |
| Row precharge time (all banks)                  | tRPab  | MIN     | max(21ns, 4nCK)                                                                         | ns                         |
| Row active time                                 | tRAS   | MIN     | max(42ns, 3nCK)                                                                         | ns                         |
| Row active time                                 | tRAS   | MAX     | Min(9 * tREFI * Refresh Rate, 70.2 us)<br>( Refresh Rate is specified by MR4, OP[2:0] ) | us                         |
| WRITE recovery time                             | tWR    | MIN     | max(18ns, 6nCK)                                                                         | ns                         |
| WRITE-to-READ delay                             | tWTR   | MIN     | max(10ns, 8nCK)                                                                         | ns                         |
| Active bank-A to active bank-B                  | tRRD   | MIN     | max(10ns, 4nCK)                                                                         | ns<br>Max<br>(7.5ns, 4nck) |
| Precharge to Precharge Delay <sup>1</sup>       | tPPD   | MIN     | 4                                                                                       | tCK                        |
| Four-bank ACTIVATE window                       | tFAW   | MIN     | 40                                                                                      | 30<br>ns                   |

**Note:**

1 Precharge to precharge timing restriction does not apply to Auto-Precharge commands.

## 9.2 Read AC Timing

Table 9-2 Read AC Timing Table

| Parameter                                 | Symbol   | Min/Max | Data Rate                                                                                                 | Unit     |
|-------------------------------------------|----------|---------|-----------------------------------------------------------------------------------------------------------|----------|
| Core Parameters                           |          |         | 533/1066/1600/2133/2667/3200/3733/4267                                                                    |          |
| READ preamble                             | tRPRE    | MIN     | 1.8                                                                                                       | tCK(avg) |
| 0.5 tCK READ postamble                    | tRPST    | MIN     | 0.4                                                                                                       | tCK(avg) |
| 1.5 tCK READ postamble                    | tRPST    | MIN     | 1.4                                                                                                       | tCK(avg) |
| DQ low-impedance time from CK_t, CK_c     | tLZ(DQ)  | MIN     | $(RL \times tCK) + tDQSCK(\text{Min}) - 200\text{ps}$                                                     | ps       |
| DQ high impedance time from CK_t, CK_c    | tHZ(DQ)  | MAX     | $(RL \times tCK) + tDQSCK(\text{Max}) + tDQSQ(\text{Max}) + (BL/2 \times tCK) - 100\text{ps}$             | ps       |
| DQS_c low-impedance time from CK_t, CK_c  | tLZ(DQS) | MIN     | $(RL \times tCK) + tDQSCK(\text{Min}) - (tRPRE(\text{Max}) \times tCK) - 200\text{ps}$                    | ps       |
| DQS_c high impedance time from CK_t, CK_c | tHZ(DQS) | MAX     | $(RL \times tCK) + tDQSCK(\text{Max}) + (BL/2 \times tCK) + (RPST(\text{Max}) \times tCK) - 100\text{ps}$ | ps       |
| DQS-DQ skew                               | tDQSQ    | MAX     | 0.18                                                                                                      | UI       |

### 9.3 tDQSCK Timing

Table 9-3 tDQSCK Timing Table

| Parameter                                                    | Symbol      | Min | Max | Unit  | Note |
|--------------------------------------------------------------|-------------|-----|-----|-------|------|
| DQS Output Access Time from CK_t/CK_c                        | tDQSCK      | 1.5 | 3.5 | ns    | 1    |
| DQS Output Access Time from CK_t/CK_c -Temperature Variation | tDQSCK_temp | -   | 4   | ps/°C | 2    |
| DQS Output Access Time from CK_t/CK_c -Voltage Variation     | tDQSCK_volt | -   | 7   | ps/mV | 3    |

**Note:**

- 1 Includes DRAM process, voltage and temperature variation. It includes the AC noise impact for frequencies > 20 MHz and max voltage of 45 mV pk-pk from DC-20 MHz at a fixed temperature on the package. The voltage supply noise must comply to the component Min-Max DC Operating conditions.
- 2 tDQSCK\_temp max delay variation as a function of Temperature.
- 3 tDQSCK\_volt max delay variation as a function of DC voltage variation for VDDQ and VDD2. tDQSCK\_volt should be used to calculate timing variation due to VDDQ and VDD2 noise < 20 MHz. Host controller do not need to account for any variation due to VDDQ and VDD2 noise > 20 MHz. The voltage supply noise must comply to the component Min-Max DC Operating conditions. The voltage variation is defined as the  $\text{Max}[\text{abs}\{\text{tDQSCKmin@V1}-\text{tDQSCKmax@V2}\}, \text{abs}\{\text{tDQSCKmax@V1}-\text{tDQSCKmin@V2}\}]/\text{abs}\{\text{V1}-\text{V2}\}$ . For tester measurement VDDQ = VDD2 is assumed.

Table 9-4 CK to DQS Rank to Rank Timing Table

| Parameter                        | Symbol           | Min/Max | Data Rate                     | Unit | Note |
|----------------------------------|------------------|---------|-------------------------------|------|------|
| Read Timing                      |                  |         | 1600/1866/2133/2667/3200/4267 | ns   | 1,2  |
| CK to DQS Rank to Rank variation | tDQSCK_rank2rank | Max     | 1.0                           |      |      |

**Note:**

- 1 The same voltage and temperature are applied to tDQS2CK\_rank2rank.
- 2 tDQSCK\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.

## 9.4 Write AC Timing

Table 9-5 Write AC Timing Table

| Parameter                          | Symbol             | Min/Max | Data Rate                              | Unit     |
|------------------------------------|--------------------|---------|----------------------------------------|----------|
| Write Timing                       |                    |         | 533/1066/1600/2133/2667/3200/3733/4267 |          |
| Write command to 1st DQS latching  | tDQSS              | Min     | 0.75                                   | tCK(avg) |
|                                    |                    | Max     | 1.25                                   |          |
| DQS input high-level               | tDQSH              | Min     | 0.4                                    | tCK(avg) |
| DQS input low-level width          | tDQSL              | Min     | 0.4                                    | tCK(avg) |
| DQS falling edge to CK setup time  | tDSS               | Min     | 0.2                                    | tCK(avg) |
| DQS falling edge hold time from CK | tDSH               | Min     | 0.2                                    | tCK(avg) |
| Write preamble                     | tWPRE              | Min     | 1.8                                    | tCK(avg) |
| 0.5 tCK Write postamble            | tWPST <sup>1</sup> | Min     | 0.4                                    | tCK(avg) |
| 1.5 tCK Write postamble            | tWPST <sup>1</sup> | Min     | 1.4                                    | tCK(avg) |

**Note:**

The length of Write Postamble depends on MR3 OP1 setting.

## 9.5 Self Refresh Timing

Table 9-6 Self Refresh AC Timing Table

| Parameter                               | Symbol | Min/Max | Data Rate                         | Unit | Note |
|-----------------------------------------|--------|---------|-----------------------------------|------|------|
|                                         |        |         | 533/1066/1600/2133/2667/3200/3733 |      |      |
| <b>Self Refresh Timing</b>              |        |         |                                   |      |      |
| Delay from SRE command to CKE Input low | tESCKE | Min     | Max(1.75ns, 3tCK)                 | ns   | 1    |
| Minimum Self Refresh Time               | tSR    | Min     | Max(15ns, 3tCK)                   | ns   | 1    |
| Exit Self Refresh to Valid commands     | tXSR   | Min     | Max(tRFCab +7.5ns,2tCK)           | ns   | 2    |

**Note:**

Delay time has to satisfy both analog time(ns) and clock count(tCK). It means that tESCKE will not expire until CK has toggled through at least 3 full cycles (3 \*tCK) and 1.75ns has transpired.

## 9.6 Mode Register Read/Write AC Timing

Table 9-7 Mode Register Read/Write AC Timing Table

| Parameter                                                             | Symbol | Min/Max | Data Rate       | Unit |
|-----------------------------------------------------------------------|--------|---------|-----------------|------|
| <b>Mode Register Read/Write Timing</b>                                |        |         |                 |      |
| Additional time after tXP has expired until MRR command may be issued | tMRRl  | Min     | tRCD + 3nCK     | -    |
| MODE REGISTER READ command period                                     | tMRR   | Min     | 8               | nCK  |
| MODE REGISTER WRITE command period                                    | tMRW   | Min     | MAX(10ns,10nCK) | -    |
| Mode register set command delay                                       | tMRD   | Min     | max(14ns,10nCK) | -    |

## 9.7 VRCG Enable/Disable Timing

Table 9-8 VRCG Enable/Disable Timing Table

| Speed                               |               | 533/1066/1600/2133/2667/3200/3733/4267 |     | Unit |
|-------------------------------------|---------------|----------------------------------------|-----|------|
| Parameter                           | Symbol        | Min                                    | Max |      |
| VREF high current mode enable time  | tVRCG_ENABLE  | -                                      | 200 | ns   |
| VREF high current mode disable time | tVRCG_DISABLE | -                                      | 100 |      |

## 9.8 Command Bus Training AC Timing

Table 9-9 Command Bus Training AC Timing Table

| Parameter                                                               | Symbol               | Min/Max | Data Rate                              | Unit |
|-------------------------------------------------------------------------|----------------------|---------|----------------------------------------|------|
|                                                                         |                      |         | 533/1066/1600/2133/2667/3200/3733/4267 |      |
| Command Bus Training Timing                                             |                      |         |                                        |      |
| Valid Clock Requirement after CKE Input low                             | tCKELCK              | Min     | Max(5ns, 5nCK)                         | -    |
| Data Setup for VREF Training Mode                                       | tDStrain             | Min     | 2                                      | ns   |
| Data Hold for VREF Training Mode                                        | tDHtrain             | Min     | 2                                      | ns   |
| Asynchronous Data Read                                                  | tADR                 | Max     | 20                                     | ns   |
| CA Bus Training Command to CA Bus Training Command Delay                | tCACD <sup>2</sup>   | Min     | RU(tADR/tCK )                          | tCK  |
| Valid Strobe Requirement before CKE Low                                 | tDQSCKE <sup>1</sup> | Min     | 10                                     | ns   |
| First CA Bus Training Command Following CKE Low                         | tCAENT               | Min     | 250                                    | ns   |
| VREF Step Time– multiple steps                                          | tVREFCA_LONG         | Max     | 250                                    | ns   |
| VREF Step Time– one step                                                | tVREFCA_SHORT        | Max     | 80                                     | ns   |
| Valid Clock Requirement before CS High                                  | tCKPRECS             | Min     | 2tck + tXP (tXP = max(7.5ns, 5nCK))    | -    |
| Valid Clock Requirement after CS High                                   | tCKPSTCS             | Min     | max(7.5ns, 5nCK))                      | -    |
| Minimum delay from CS to DQS toggle in command bus training             | tCS_VREF             | Min     | 2                                      | tCK  |
| Minimum delay from CKE High to Strobe High Impedance                    | tCKEHDQS             | Min     | 10                                     | ns   |
| Valid Clock Requirement before CKE Input High                           | tCKCKEH              | Min     | Max(1.75ns, 3nCK)                      | -    |
| CA Bus Training CKE High to DQ Tri-state                                | tMRZ                 | Min     | 1.5                                    | ns   |
| ODT turn-on Latency from CKE                                            | tCKELODTon           | Min     | 20                                     | ns   |
| ODT turn-off Latency from CKE                                           | tCKELODToff          | Min     | 20                                     | ns   |
| Exit Command Bus Training Mode to next valid command delay <sup>3</sup> | tXCBT_Short          | Min     | Max(5nCK, 200ns)                       | -    |
|                                                                         | tXCBT_Middle         | Min     | Max(5nCK, 200ns)                       | -    |
|                                                                         | tXCBT_Long           | Min     | Max(5nCK, 250ns)                       | -    |

**Note:**

- 1 DQS<sub>t</sub> has to retain a low level during tDQSCKE period, as well as DQS<sub>c</sub> has to retain a high level.
- 2 If tCACD is violated, the data for samples which violate tCACD will not be available, except for the last sample (where tCACD after this sample is met). Valid data for the last sample will be available after tADR.
- 3 Exit Command Bus Training Mode to next valid command delay Time depends on value of VREF(CA) setting: MR12 OP[5:0] and VREF(CA) Range: MR12 OP[6] of FSP-OP 0 and 1. The details are shown in Table 61. Additionally exit Command Bus Training Mode to next valid command delay Time may affect VREF(DQ) setting. Settling time of VREF(DQ) level is same as VREF(CA) level.

Table 9-10 Command Bus Training AC Timing Table for Mode 1

| Parameter                                                  | Symbol       | Min/Max | Data Rate                              | Unit | Note |
|------------------------------------------------------------|--------------|---------|----------------------------------------|------|------|
|                                                            |              |         | 533/1066/1600/2133/2667/3200/3733/4267 |      |      |
| Command Bus Training Timing                                |              |         |                                        |      |      |
| Clock and Command Valid after CKE Low                      | tCKELCK      | Min     | max(7.5ns, 3nCK)                       | tCK  |      |
| Asynchronous Data Read                                     | tADR         | Max     | 20                                     | ns   |      |
| CA Bus Training Command to CA Bus Training Command Delay   | tCACD        | Min     | RU(tADR/tCK )                          | tCK  | 1    |
| First CA Bus Training Command Following CKE Low            | tCAENT       | Min     | 250                                    | ns   |      |
| Valid Clock Requirement before CS High                     | tCKPRECS     | Min     | 2tCK + tXP (tXP = max(7.5ns, 5nCK))    |      |      |
| Valid Clock Requirement after CS High                      | tCKPSTCS     | Min     | max(7.5ns, 5nCK))                      |      |      |
| Clock and Command Valid before CKE High                    | tCKCKEH      | Min     | 2                                      | tCK  |      |
| CA Bus Training CKE High to DQ Tri-state                   | tMRZ         | Min     | 1.5                                    | ns   |      |
| ODT turn-on Latency from CKE                               | tCKELODTon   | Min     | 20                                     | ns   |      |
| ODT turn-off Latency from CKE                              | tCKELODToff  | Min     | 20                                     | ns   |      |
| Exit Command Bus Training Mode to next valid command delay | tXCBT_Short  | Min     | Max(5nCK, 200ns)                       |      | 2    |
|                                                            | tXCBT_Middle | Min     | Max(5nCK, 200ns)                       |      | 2    |
|                                                            | tXCBT_Long   | Min     | Max(5nCK, 250ns)                       |      | 2    |

**Note:**

- 1 If tCACD is violated, the data for samples which violate tCACD will not be available, except for the last sample (where tCACD after this sample is met). Valid data for the last sample will be available after tADR.
- 2 Exit Command Bus Training Mode to next valid command delay Time depends on value of VREF(CA) setting: MR12 OP[5:0] and VREF(CA) Range: MR12 OP[6] of FSP-OP 0 and 1. Additionally exit Command Bus Training Mode to next valid command delay Time may affect VREF(DQ) setting. Settling time of VREF(DQ) level is same as VREF(CA) level.

Table 9-11 Command Bus Training AC Timing Table for Mode 2

| Parameter                                                | Symbol         | Min/Max | Data Rate                              | Unit | Note |
|----------------------------------------------------------|----------------|---------|----------------------------------------|------|------|
|                                                          |                |         | 533/1066/1600/2133/2667/3200/3733/4267 |      |      |
| Command Bus Training Timing                              |                |         |                                        |      |      |
| Valid Clock Requirement after CKE Input low              | tCKELCK        | Min     | Max(5ns,5nCK)                          | ns   |      |
| Valid Clock Requirement before CS High                   | tCKPRECS       | Min     | 2tCK + tXP (tXP = max(7.5ns, 5nCK))    | -    |      |
| Valid Clock Requirement after CS High                    | tCKPSTCS       | Min     | max(7.5ns, 5nCK))                      | -    |      |
| Valid Strobe Requirement before CKE Low                  | tDQSCKE        | Min     | 10                                     | ns   | 1    |
| First CA Bus Training Command Following CKE Low          | tCAENT         | Min     | 250                                    | ns   |      |
| VREF Step Time - Long                                    | tVREFCA_Long   | Max     | 250                                    | ns   | 2    |
| VREF Step Time - Middle                                  | tVREFCA_Middle | Max     | 200                                    | ns   | 3    |
| VREF Step Time - Short                                   | tVREFCA_Short  | Max     | 100                                    | ns   | 4    |
| Data Setup for Vref Training Mode                        | tDStrain       | Min     | 2                                      | ns   |      |
| Data Hold for Vref Training Mode                         | tDHtrain       | Min     | 2                                      | ns   |      |
| Asynchronous Data Read Valid Window                      | tADVW          | Min     | 16                                     | ns   |      |
|                                                          |                | Max     | 80                                     | ns   |      |
| DQS Input period at CBT mode                             | tDQSICYC       | Min     | 5                                      | ns   |      |
|                                                          |                | Max     | 100                                    | ns   |      |
| Asynchronous Data Read                                   | tADR           | Max     | 20                                     | ns   |      |
| DQS_c high impedance time from CS High                   | tHZCBT         | Min     | 0                                      | ns   |      |
| Asynchronous Data Read to DQ7 toggle                     | tAD2DQ7        | Min     | 3                                      | ns   |      |
|                                                          |                | Max     | 10                                     | ns   |      |
| DQ7sample hold time                                      | tDQ7SH         | Min     | 10                                     | ns   |      |
|                                                          |                | Max     | 60                                     | ns   |      |
| Asynchronous Data Read Pulse Width                       | tADSPW         | Min     | 3                                      | ns   |      |
|                                                          |                | Max     | 10                                     | ns   |      |
| Hi-Z to asynchronous Vref-CA valid data                  | tHZ2VREF       | Min     | Max(10ns, 5nCK)                        | -    |      |
| Read to Write Delay at CBT mode                          | tCBTRTW        | Min     | 2                                      | ns   |      |
| CA Bus Training Command to CA Bus Training Command Delay | tCACD          | Min     | Max(110ns, 4nCK)                       |      |      |
| Minimum delay from CKE High to Strobe High Impedance     | tCKEHDQS       | Min     | 10                                     | ns   |      |
| Clock and Command Valid before CKE High                  | tCKCKEH        | Min     | Max(1.75ns,3nCK)                       |      |      |
| ODT turn-on Latency from CKE                             | tCKELODTon     | Max     | 20                                     | ns   |      |
| ODT turn-off Latency from CKE for ODT CA                 | tCKELODToff    | Max     | 20                                     | ns   |      |

| Parameter                                                  | Symbol       | Min/Max | Data Rate                              | Unit | Note |
|------------------------------------------------------------|--------------|---------|----------------------------------------|------|------|
|                                                            |              |         | 533/1066/1600/2133/2667/3200/3733/4267 |      |      |
| ODT turn-off Latency from CKE for ODT_DQ and DQS           | tCKEHODTOff  | Max     | 20                                     | ns   |      |
| ODT_DQ turn-off Latency from CS high during CB Training    | tODTOffCBT   | Max     | 20                                     | ns   |      |
| ODT_DQ turn-on Latency from the end of Valid Data out      | tODTonCBT    | Max     | Max(10ns, 5nCK)                        |      |      |
| Exit Command Bus Training Mode to next valid command delay | tXCBT_Short  | Min     | Max(5nCK, 200ns)                       |      | 5    |
|                                                            | tXCBT_Middle | Min     | Max(5nCK, 200ns)                       |      | 5    |
|                                                            | tXCBT_Long   | Min     | Max(5nCK, 250ns)                       |      | 5    |

**Note:**

- 1 DQS\_t has to retain a low level during tDQSCKE period, as well as DQS\_c has to retain a high level.
- 2 VREFCA\_Long is the time including up to VREFmin to VREFmax or VREFmax to VREFmin change across the VREFDQ Range in VREF voltage.
- 3 VREF\_Middle is at least 2 stepsizes increment/decrement change within the same VREFDQ range in VREF voltage.
- 4 VREF\_Short is for a single stepsize increment/decrement change in VREF voltage.
- 5 Exit Command Bus Training Mode to next valid command delay Time depends on value of VREF(CA) setting: MR12 OP[5:0] and VREF(CA) Range: MR12 OP[6] of FSP-OP 0 and 1.

## 9.9 Frequency Set Point Timing

Table 9-12 Frequency Set Point Timing Table

| Parameter                                                         | Symbol                  | Min/Max | Data Rate                              | Unit |
|-------------------------------------------------------------------|-------------------------|---------|----------------------------------------|------|
|                                                                   |                         |         | 533/1066/1600/2133/2667/3200/3733/4267 |      |
| Frequency Set Point parameters                                    |                         |         |                                        |      |
| Frequency Set Point Switching Time                                | tFC_Short <sup>1</sup>  | Min     | 200                                    | ns   |
| Minimum Self Refresh Time                                         | tFC_Middle <sup>1</sup> | Min     | 200                                    | ns   |
| Exit Self Refresh to Valid commands                               | tFC_Long <sup>1</sup>   | Min     | 250                                    | ns   |
| Valid Clock Requirement after Entering FSP Change                 | tCKFSPE                 | Min     | max(7.5ns, 4nCK)                       | -    |
| Valid Clock Requirement before 1st Valid Command after FSP change | tCKFSPX                 | Min     | max(7.5ns, 4nCK)                       | -    |

**Note:**

Frequency Set Point Switching Time depends on value of VREF(CA) setting: MR12 OP[5:0] and VREF(CA) Range: MR12 OP[6] of FSP-OP 0 and 1. Additionally change of Frequency Set Point may affect VREF(DQ) setting. Settling time of VREF(DQ) level is same as VREF(CA) level.

## 9.10 Write Leveling Timing

Table 9-13 Write Leveling Timing Table

| Parameter                                                      | Symbol    | Min/Max | Value            | Unit |
|----------------------------------------------------------------|-----------|---------|------------------|------|
| DQS_t/DQS_c delay after write leveling mode is programmed      | tWLDQSEN  | Min     | 20               | tCK  |
|                                                                |           | Max     | -                |      |
| Write preamble for Write Leveling                              | tWLWPRE   | Min     | 20               | tCK  |
|                                                                |           | Max     | -                |      |
| First DQS_t/DQS_c edge after write leveling mode is programmed | tWLMRD    | Min     | 40               | tCK  |
|                                                                |           | Max     | -                |      |
| Write leveling output delay                                    | tWLO      | Min     | 0                | ns   |
|                                                                |           | Max     | 20               |      |
| Mode register set command delay                                | tMRD      | Min     | max(14ns, 10nCK) | ns   |
|                                                                |           | Max     | -                |      |
| Valid Clock Requirement before DQS Toggle                      | tCKPRDQS  | Min     | max(7.5ns, 4nCK) | -    |
|                                                                |           | Max     | -                |      |
| Valid Clock Requirement after DQS Toggle                       | tCKPSTDQS | Min     | max(7.5ns, 4nCK) | -    |
|                                                                |           | Max     | -                |      |

Table 9-14 Write Leveling Setup and Hold Time

| Parameter                           | Symbol | Min/Max | Data Rate |      |      |      | Unit |
|-------------------------------------|--------|---------|-----------|------|------|------|------|
|                                     |        |         | 1600      | 2400 | 3200 | 4266 |      |
| Write Leveling Parameters           |        |         |           |      |      |      |      |
| Parameters Write leveling hold time | tWLH   | Min     | 150       | 100  | 75   | 50   | ps   |
| Write leveling setup time           | tWLS   | Min     | 150       | 100  | 75   | 50   | ps   |
| Write leveling input valid window   | tWLIVW | Min     | 240       | 160  | 120  | 90   | ps   |

## 9.11 MPC [Write FIFO] AC Timing

Table 9-15 MPC [Write FIFO] AC Timing Table

| Parameter                                                                          | Symbol | Min/Max | Data Rate                         |
|------------------------------------------------------------------------------------|--------|---------|-----------------------------------|
|                                                                                    |        |         | 533/1066/1600/2133/2667/3200/3733 |
| MPC Write FIFO Timing                                                              |        |         |                                   |
| Additional time after tXP has expired until MPC [Write FIFO] command may be issued | tMPCWR | Min     | tRCD + 3nCK                       |

## 9.12 DQS Interval Oscillator AC Timing

Table 9-16 DQS Interval Oscillator AC Timing Table

| Parameter                                         | Symbol | Min/Max | Value          | Unit |
|---------------------------------------------------|--------|---------|----------------|------|
| Delay time from OSC stop to Mode Register Readout | tOSCO  | Min     | Max(40ns,8nCK) | ns   |

### Note:

Start DQS OSC command is prohibited until tOSCO(Min) is satisfied.

## 9.13 Read Preamble Training Timing

Table 9-17 Read Preamble Training Timing Table

| Parameter                            | Symbol | Min | Max              |
|--------------------------------------|--------|-----|------------------|
| Delay from MRW command to DQS Driven | tSDO   | -   | Min(12nCK, 20ns) |

## 9.14 ZQ Calibration Timing

Table 9-18 ZQCal Timing Table

| Parameter                 | Symbol   | Min /Max | Value          | Unit |
|---------------------------|----------|----------|----------------|------|
| ZQ Calibration Time       | tZQCAL   | Min      | 1              | us   |
| ZQ Calibration Latch Time | tZQLAT   | Min      | max(30ns,8nCK) | ns   |
| ZQ Calibration Reset Time | tZQRESET | Min      | max(50ns,3nCK) | ns   |

## 9.15 ODT CA AC Timing

Table 9-19 ODT CAAC Timing Table

| Speed                    |        | 1600/1866/2133/2400/3200/4266 |     |
|--------------------------|--------|-------------------------------|-----|
| Parameter                | Symbol | MIN                           | MAX |
| ODT CA Value Update Time | tODTUP | RU(TBDns/tCK(avg))            | -   |

## 9.16 Power-Down AC Timing

Table 9-20 Power-Down AC Timing

| Parameter                                                                             | Symbol   | Min/Max | Data Rate                             | Unit | Note |
|---------------------------------------------------------------------------------------|----------|---------|---------------------------------------|------|------|
|                                                                                       |          |         | 533/1066/1600/2133<br>/2667/3200/3733 |      |      |
| Power Down Timing                                                                     |          |         |                                       |      |      |
| CKE minimum pulse width (HIGH and LOW pulse width) tCKE                               | tCKE     | Min     | Max(7.5ns,4nCK)                       | -    |      |
| Delay from valid command to CKE input LOW                                             | tCMDCKE  | Min     | Max(1.75ns,3nCK)                      | ns   | 1    |
| Valid Clock Requirement after CKE Input low                                           | tCKELCK  | Min     | Max(5ns,5nCK)                         | ns   | 1    |
| Valid CS Requirement before CKE Input Low                                             | tCSCKE   | Min     | 1.75                                  | ns   |      |
| Valid CS Requirement after CKE Input low                                              | tCKELCS  | Min     | Max(5ns,5nCK)                         | ns   |      |
| Valid Clock Requirement before CKE Input High                                         | tCKCKEH  | Min     | Max(1.75ns,3nCK)                      | ns   | 1    |
| Exit power- down to next valid command delay                                          | tXP      | Min     | Max(7.5ns,5nCK)                       | ns   | 1    |
| Valid CS Requirement before CKE Input High                                            | tCSCKEH  | Min     | 1.75                                  | ns   |      |
| Valid CS Requirement after CKE Input High                                             | tCKEHCS  | Min     | Max(7.5ns,5nCK)                       | ns   |      |
| Valid Clock and CS Requirement after CKE Input low after MRW Command                  | tMRWCKEL | Min     | Max(14ns,10nCK)                       | ns   | 1    |
| Valid Clock and CS Requirement after CKE Input low after ZQ Calibration Start Command | tZQCKE   | Min     | Max(1.75ns,3nCK)                      | ns   | 1    |
| Note:                                                                                 |          |         |                                       |      |      |
| Delay time has to satisfy both analog time(ns) and clock count(nCK).                  |          |         |                                       |      |      |